

## **Freescale Semiconductor**

Data Sheet: Advance Information

Document Number: MCF51EM256

Rev.3, 8/2010



## **MCF51EM256**

# MCF51EM256 Series ColdFire Microcontroller

Covers: MCF51EM256 MCF51EM128

The MCF51EM256/128 series microcontrollers are a member of the ColdFire<sup>®</sup> family of reduced instruction set computing (RISC) microprocessors.

This document provides an overview of these 32-bit microcontrollers, focusing on their highly integrated and diverse feature set.

These microcontrollers are systems-on-chips (SoCs) that are based on the V1 ColdFire core and the following features:

- Operating at processor core speeds up to 50.33 MHz (peripherals operate at half of this speed) at 3.6 V to 2.5 V and 20 MHz at 3.6 V to 1.8 V
- Up to 256 KB of flash memory
- Up to 16 KB of RAM
- Less than 1.3 μA of typical power consumption in battery mode, with MCU supply off
- Ultra-low power independent RTC with calendar features, separate time base, power domain, and 32 bytes of RAM
- A collection of communications peripherals, including UART, IIC and SPI
- Integrated 16-bit SAR analog-to-digital converter
- Programmable delay block (PDB)
- Two analog comparators with selectable interrupt (PRACMP)
- LCD driver

80 LQFP 14 mm × 14 mm 917A-03



- Three serial communications interface modules (SCI)
- Three serial peripheral interfaces
- Inter-integrated circuit (IIC)
- Two 8-bit and one 16-bit modulo timers (MTIM)
- Two-channel timer/PWM module (TPM)

This document contains information on a product under development. Freescale reserves the right to change or discontinue this product without notice.

© Freescale Semiconductor, Inc., 2008-2010. All rights reserved.





## **Table of Contents**

| 1 | MCF   | 51EM256 Series Configurations                            |
|---|-------|--|
|   | 1.1   | Device Comparison  |
|   | 1.2   | Block Diagram4   |
|   | 1.3   | Features   |
|   |       | 1.3.1 Feature List                                       |
|   | 1.4   | Part Numbers   |
|   | 1.5   | Pinouts and Packaging                                    |
|   |       | 1.5.1 Pinout: 80-Pin LQFP                                |
|   |       | 1.5.2 Pinout: 100-Pin LQFP                               |
| 2 | Elect | trical Characteristics16                                 |
|   | 2.1   | Parameter Classification                                 |
|   | 2.2   | Absolute Maximum Ratings17                               |
|   | 2.3   | Thermal Characteristics                                  |
|   | 2.4   | Electrostatic Discharge (ESD) Protection Characteristics |
|   |       | 19   |
|   | 2.5   | DC Characteristics20                                     |
|   | 2.6   | Supply Current Characteristics                           |
|   | 2.7   | Analog Comparator (PRACMP) Electricals27                 |
|   | 28    | ADC Characteristics 27                                   |

|   | 2.9   | External Oscillator (XOSC) Characteristics     |
|---|-------|--|
|   | 2.10  | Internal Clock Source (ICS) Characteristics 35 |
|   | 2.11  | LCD Specifications                             |
|   | 2.12  | AC Characteristics                             |
|   |       | 2.12.1 Control Timing                          |
|   |       | 2.12.2 Timer (TPM/FTM) Module Timing 39        |
|   | 2.13  | VREF Characteristics 40                        |
|   | 2.14  | SPI Characteristics 40                         |
|   | 2.15  | Flash Specifications43                         |
|   | 2.16  | EMC Performance                                |
|   |       | 2.16.1 Radiated Emissions                      |
| 3 | Mech  | anical Outline Drawings                        |
|   | 3.1   | 80-pin LQFP Package                            |
|   | 3.2   | 100-pin LQFP Package                           |
| ŀ | Revis | ion History                                    |
|   |       |  |



## 1.1 Device Comparison

The MCF51EM256 series is summarized in Table 1.

Table 1. MCF51EM256 Series Features by MCU and Package

| Feature                                | MCF51 | EM256 | MCF51  | EM128 |
|--|-------|-------|--------|-------|
| Flash size (bytes)                     | 262   | 144   | 131072 |       |
| RAM size (bytes)                       | 163   | 384   | 81     | 92    |
| Robust flash update supported          |       | Ye    | es     |       |
| Pin quantity                           | 100   | 80    | 100    | 80    |
| PRACMP1 inputs                         | 5     | 3     | 5      | 3     |
| PRACMP2 inputs                         |       | Ę     | 5      |       |
| ADC modules                            | 2     | 4     | 2      | 1     |
| ADC differential channels <sup>1</sup> | 4     | 2     | 4      | 2     |
| ADC single-ended channels              | 16    | 12    | 16     | 12    |
| DBG                                    |       | Ye    | es     |       |
| ICS                                    |       | Ye    | es     |       |
| IIC                                    |       | Ye    | es     |       |
| IRQ                                    | Yes   |       |        |       |
| IRTC                                   |       | Ye    | es     |       |
| VREF                                   |       | Ye    | es     |       |
| LCD drivers                            | 44    | 37    | 44     | 37    |
| Rapid GPIO <sup>2</sup>                | 16    | 16    | 16     | 16    |
| Port I/O <sup>3</sup>                  | 47    | 40    | 47     | 40    |
| Keyboard interface 1                   | 8     |       |        |       |
| Keyboard interface 2                   |       | 8     | 3      |       |
| SCI1                                   |       | Ye    | es     |       |
| SCI2                                   | Yes   |       |        |       |
| SCI3                                   |       | Ye    | es     |       |
| SPI1 (FIFO)                            | Yes   |       |        |       |
| SPI2 (standard)                        |       | Ye    | es     |       |
| SPI3 (standard)                        | Yes   | No    | Yes    | No    |

MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3



Table 1. MCF51EM256 Series Features by MCU and Package (continued)

| Feature            | MCF51EM256 | MCF51EM128 |  |
|--------------------|------------|------------|--|
| MTIM1 (8-bit)      | Ye         | es         |  |
| MTIM2 (8-bit)      | Ye         | es         |  |
| MTIM3 (16-it)      | Yes        |            |  |
| TPM channels       | 2          | 2          |  |
| PDB                | Ye         | es         |  |
| XOSC1 <sup>4</sup> | Ye         | es         |  |
| XOSC2 <sup>5</sup> | Ye         | es         |  |

<sup>1</sup> Each differential channel is comprised of 2 pin inputs

## 1.2 Block Diagram

Figure 1 shows the connections between the MCF51EM256 series pins and modules.

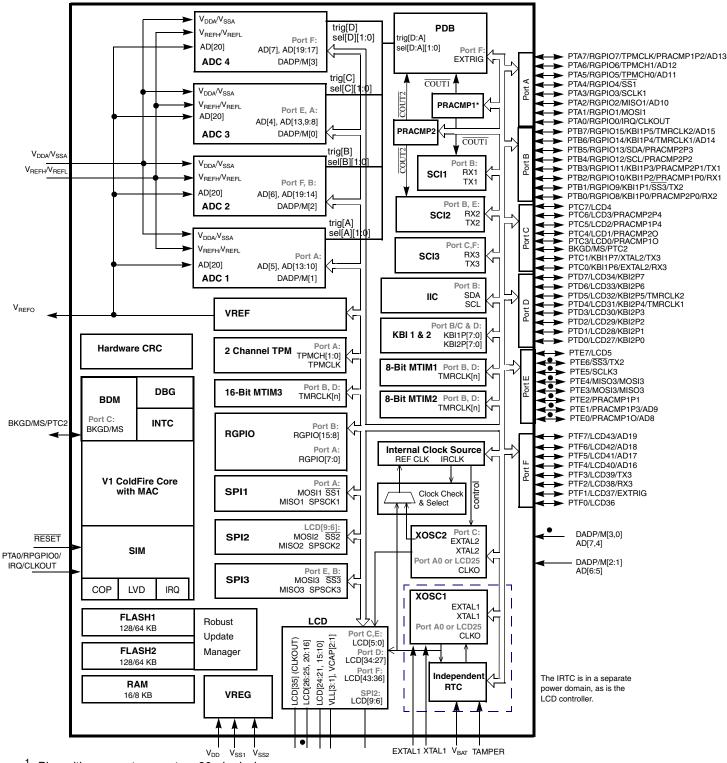
<sup>&</sup>lt;sup>2</sup> RGPIO is muxed with standard Port I/O

<sup>&</sup>lt;sup>3</sup> Port I/O count does not include the ouput only PTC2/BKGD/MS.

<sup>&</sup>lt;sup>4</sup> IRTC crystal input and possible crystal input to the ICS module

<sup>&</sup>lt;sup>5</sup> Main external crystal input for the ICS module





Pins with • are not present on 80-pin devices.

Figure 1. MCF51EM256 Series Block Diagram

<sup>&</sup>lt;sup>2</sup> PRACMP1 has two less available inputs on the 80-pin devices.



## 1.3 Features

Table 2 describes the functional units of the MCF51EM256 series.

Table 2. MCF51EM256 Series Functional Units

| Table II mer er imited dende i anottenar erite |   |  |  |  |
|--|---|--|--|--|
| Unit   | Function  |  |  |  |
| ADC (analog-to-digital converter)              | Measures analog voltages at up to 16 bits of resolution. Each ADC has up to four differential and 24 single-ended inputs.   |  |  |  |
| BDM (background debug module)                  | Provides single pin debugging interface (part of the V1 ColdFire core)  |  |  |  |
| CF1 CORE (V1 ColdFire core) with MAC unit      | Executes programs, handles interrupts and containes multiply-accumulate hardware (MAC).   |  |  |  |
| PRACMP1, PRACMP2 (comparators)                 | Analog comparators for comparing external analog signals against each other, or a variety of reference levels.  |  |  |  |
| COP (computer operating poperly)               | Software watchdog   |  |  |  |
| IRQ (interrupt request)                        | Single pin high priority interrupt (part of the V1 ColdFire core)   |  |  |  |
| CRC (cyclic Redundancy Check)                  | High-speed CRC calculation  |  |  |  |
| DBG (debug)                                    | Provides debugging and emulation capabilities (part of the V1 ColdFire core)  |  |  |  |
| FLASH (flash memory)                           | Provides storage for program code, constants and variables  |  |  |  |
| IIC (inter-integrated circuits)                | Supports standard IIC communications protocol and SMBus   |  |  |  |
| INTC (interrupt controller)                    | Controls and prioritizes all device interrupts  |  |  |  |
| KBI1 & KBI2                                    | Keyboard Interfaces 1 and 2   |  |  |  |
| LCD  | Liquid crystal display driver   |  |  |  |
| LVD (low voltage detect)                       | Provides an interrupt to the CF1CORE in the event that the supply voltage drops below a critical value. The LVD can also be programmed to reset the device upon a low voltage event |  |  |  |
| ICS (internal clock source)                    | Provides clocking options for the device, including a three frequency-locked loops (FLLs) for multiplying slower reference clock sources  |  |  |  |
| IRTC (independent real-time clock)             | The independent real time clock provides an independent time-base with optional interrupt, battery backup and tamper protection   |  |  |  |
| VREF (voltage reference)                       | The voltage reference output is available for both on and off-chip use  |  |  |  |
| MTIM1, MTIM2 (modulo timers)                   | 8-bit modulo timers with configurable clock inputs and interrupt generation on overflow   |  |  |  |
| MTIM3 (modulo timer)                           | 16-bit modulo timer with configurable clock inputs and interrupt generation on overflow   |  |  |  |
| PDB (programmable delay block)                 | This timer is optimized for scheduling ADC conversions  |  |  |  |
| RAM (random-access memory)                     | Provides stack and variable storage   |  |  |  |
| RGPIO (rapid general-purpose input/output)     | Allows for I/O port access at CPU clock speeds and is used to implement GPIO functionality for PTA and PTB.   |  |  |  |



Table 2. MCF51EM256 Series Functional Units (continued)

| Unit   | Function   |
|--|--|
| SCI1, SCI2, SCI3(serial communications interfaces)     | Serial communications UARTs capable of supporting RS-232 and LIN protocols   |
| SIM (system integration unit)                          |  |
| SPI1 (FIFO), SPI2, SPI3 (serial peripheral interfaces) | SPI1 has full-complementary drive outputs. SPI2 may be configured with full-complementary drive output via LCD control registers. SPI3 has open drain outputs on SCLK and (MISO or MOSI). These coupled with off-chip pull-up resistors, allow interface to an external 5 V SPI. |
| TPM (Timer/PWM Module)                                 | Timer/PWM module can be used for a variety of generic timer operations as well as pulse-width modulation   |
| VREG (voltage regulator)                               | Controls power management across the device  |
| XOSC1 and XOSC2 (crystal oscillators)                  | These devices incorporate redundant crystal oscillators in separate power domains. One is intended primarily for use by the IRTC, and the other by the CPU and other peripherals.  |

### 1.3.1 Feature List

- 32-bit ColdFire V1 central processor unit (CPU)
  - Up to 50.33 MHz ColdFire CPU from 3.6 V to 2.5 V and 20 MHz CPU at 3.6 V to 1.8 V across temperature range of -40 °C to 85 °C
  - ColdFire instruction set revision C (ISA\_C) plus MAC
  - 32-bit multiply and accumulate (MAC) optimized for 16×16±32 operations; supports signed or unsigned integer or signed fractional inputs
- On-chip memory
  - MCF51EM256/128 series support two independent flash arrays; read/program/erase over full operating voltage and temperature; allows interrupt processing while programming for robust program updates
  - Random-access memory (RAM)
  - Security circuitry to prevent unathorized access to RAM and Flash contents
- Power-saving modes
  - Two ultra-low power stop modes
  - New low-power run and low-power wait modes
  - Reduced power wait mode
  - Peripheral clock enable register can disable clocks to unused modules, thereby reducing currents
  - Ultra-low power independent real time clock with calendar features (IRTC); runs in all MCU modes; external clock source with trim capabilities; independent voltage source runs IRTC when MCU is powered-down; tamper detection and indicator; battery monitor output to ADC; unaffected by MCU resets
  - Ultra-low power external oscillator that can be used in stop modes to provide accurate clock source to IRTC, ICS and LCD



- 6 µs typical wakeup time from stop3 mode
- Clock source options
  - Two independent oscillators (XOSC1 and XOSC2) loop-control Pierce oscillator; 32.768 kHz crystal or ceramic resonator. XOSC1 nominally supports the independent real time clock, and can be powered by a separate battery backup. XOSC2 is the primary external clock source for the ICS
  - Internal clock source (ICS) internal clock source module containing a frequency-locked-loop (FLL) controlled by internal or external reference (XOSC1 or XOSC2); precision trimming of internal reference allowing 0.2% resolution and typical 0.5% to -1% deviation over temperature and voltage; supporting CPU frequencies from 4 kHz to 50 MHz

### • System protection

- Watchdog computer operating properly (COP) reset with option to run from dedicated 1 kHz internal clock source or bus clock
- Low voltage detection with reset or interrupt; selectable trip points; seperate low voltage warning with optional interrupt; selectable trip points
- Illegal opcode and illegal address detection with reset
- Flash block protection for each array to prevent accidental write/erasure
- Hardware CRC module to support fast cyclic redundancy checks

### • Development support

- Integrated ColdFire DEBUG\_Rev\_B+ interface with single wire BDM connection supports same electrical interface used by the S08 family debug modules
- Real-time debug support with six hardware breakpoints (4 PC, 1 address and 1 data)
- On-chip trace buffer provides programmable start/stop recording conditions

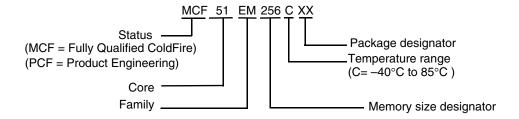
#### Peripherals

- ADC16 4 analog-to-digital converters; the 100 pin version of the device has 1 dedicated differential channel and 1 dedicated single-ended channel per ADC, along with 3 muxed single-ended channels per ADC. The ADCs have 16-bit resolution, range compare function, 1.7 mV/°C temperature sensor, internal bandgap reference channel, operate in stop3 and are fully functional from 3.6 V to 1.8 V
- PDB Programmable delay block with 16-bit counter and modulus and 3-bit prescaler; 8 trigger outputs for ADC16 modules (2 per ADC); provides periodic coordination of ADC sampling sequence with programmable sequence completion interrupt
- IRTC Ultra-low power independent real time clock with calendar features (IRTC); runs in all MCU modes; external clock source with trim capabilities (XOSC1); independent voltage source runs IRTC when MCU is powered-down; tamper detection and indicator; battery monitor output to ADC; unaffected by MCU resets
- PRACMPx Two analog comparators with selectable interrupt on rising, falling, or either edge of comparator output; compare option to programmable internal reference voltage; operation in stop3
- LCD up to 288 segments  $(8 \times 36)$ ; 160 segments  $(4 \times 40)$ ; internal charge pump and option to provide internal reference voltage that can be trimmed for contrast control; flexible



- front-plane/backplane pin assignments; operation in all low power modes with blink functionality
- SCIx Three serial communications interface modules with optional 13-bit break; option to connect Rx input to PRACMP output on SCI1 and SCI2; high current drive on Tx on SCI1 and SCI2; wakeup from stop3 on Rx edge. SCI1 and SCI2 Tx pins can be modulated with timer outputs for use with IR interfaces
- SPIx— Two serial peripheral interfaces (SPI2, SPI3) with full-duplex or single-wire bidirectional; double-buffered transmit and receive; master or slave mode; MSB-first or LSB-first shifting
- SPI16— Serial peripheral interface (SPI1) with 32-bit FIFO buffer; 16-bit or 8-bit data transfers; full-duplex or single-wire bidirectional; double-buffered transmit and receive; master or slave mode; MSB-first or LSB-first shifting
- IIC Up to 100 kbps with maximum bus loading; multi-master operation; programmable slave address; interrupt driven byte-by-byte data transfer; supports broadcast mode and 10 bit addressing
- **MTIMx** Two 8-bit and one 16-bit modulo timers with 4-bit prescaler; overflow interrupt; external clock input/pulse accumulator
- TPM 2-channel Timer/PWM module; selectable input capture, output compare, or buffered edge- or center-aligned PWM on each channel; external clock input/pulse accumulator; can be used modulate SCI1 and SCI2 TX pins
- Input/output
  - up to 16 rapid GPIO and 48 standard GPIOs, including 1 output-only pin and 3 open-drain pins.
  - up to 16 keyboard interrupts with selectable polarity
  - Hysteresis and configurable pullup device on all input pins; configurable slew rate and drive strength on all output pins
- Package options
  - 100-pin LQFP, 80-pin LQFP

### 1.4 Part Numbers





## **Table 3. Orderable Part Number Summary**

| Freescale Part Number | Flash / SRAM (KB) | Package      | Temperature   |
|-----------------------|-------------------|--------------|---------------|
| MCF51EM256CLL         | 256/16            | 100-Pin LQFP | –40°C to 85°C |
| MCF51EM256CLK         | 256/16            | 80-Pin LQFP  | –40°C to 85°C |
| MCF51EM128CLL         | 128/16            | 100-Pin LQFP | –40°C to 85°C |
| MCF51EM128CLK         | 128/16            | 80-Pin LQFP  | -40°C to 85°C |



## 1.5 Pinouts and Packaging

### 1.5.1 Pinout: 80-Pin LQFP

Pins not available on the 80-pin LQFP are automatically disabled for reduced current consumption. No user interaction is needed. Software access to the functions on these pins will be ignored

Figure 2 shows the pinout of the 80-pin LQFP.

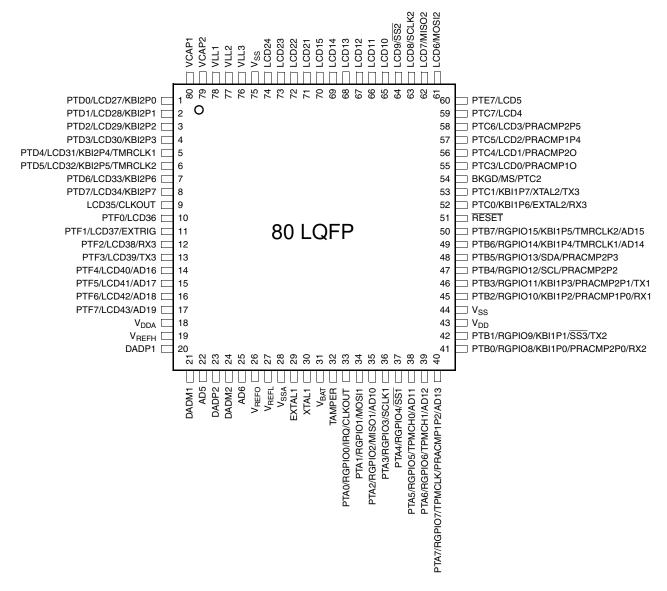


Figure 2. 80-Pin LQFP Pinout



### 1.5.2 Pinout: 100-Pin LQFP

Figure 3 shows the pinout configuration for the 100-pin LQFP. Pins which are blacked out do not have an equivalent pin on the 80-pin LQFP package.

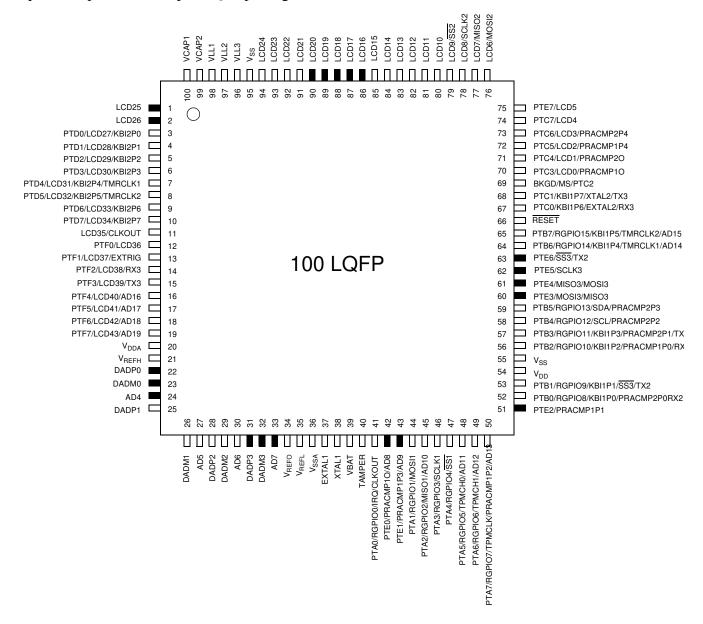


Figure 3. 100-Pin LQFP Pinout

Table 4 shows the package pin assignments.



Table 4. MCF51EM256 Series Package Pin Assignments

| 100<br>LQFP | 80<br>LQFP | Default Function | ALT1   | ALT2   | ALT3    | Comment |
|-------------|------------|------------------|--------|--------|---------|---------|
| 1           | _          | LCD25            |        |        |         |         |
| 2           | _          | LCD26            |        |        |         |         |
| 3           | 1          | PTD0             | LCD27  | KBI2P0 |         |         |
| 4           | 2          | PTD1             | LCD28  | KBI2P1 |         |         |
| 5           | 3          | PTD2             | LCD29  | KBI2P2 |         |         |
| 6           | 4          | PTD3             | LCD30  | KBI2P3 |         |         |
| 7           | 5          | PTD4             | LCD31  | KBI2P4 | TMRCLK1 |         |
| 8           | 6          | PTD5             | LCD32  | KBI2P5 | TMRCLK2 |         |
| 9           | 7          | PTD6             | LCD33  | KBI2P6 |         |         |
| 10          | 8          | PTD7             | LCD34  | KBI2P7 |         |         |
| 11          | 9          | LCD35            | CLKOUT |        |         |         |
| 12          | 10         | PTF0             | LCD36  |        |         |         |
| 13          | 11         | PTF1             | LCD37  |        | EXTRIG  |         |
| 14          | 12         | PTF2             | LCD38  |        | RX3     |         |
| 15          | 13         | PTF3             | LCD39  |        | TX3     |         |
| 16          | 14         | PTF4             | LCD40  |        | AD16    |         |
| 17          | 15         | PTF5             | LCD41  |        | AD17    |         |
| 18          | 16         | PTF6             | LCD42  |        | AD18    |         |
| 19          | 17         | PTF7             | LCD43  |        | AD19    |         |
| 20          | 18         | $V_{DDA}$        |        |        |         |         |
| 21          | 19         | $V_{REFH}$       |        |        |         |         |
| 22          | _          | DADP0            |        |        |         |         |
| 23          | _          | DADM0            |        |        |         |         |
| 24          | _          | AD4              |        |        |         |         |
| 25          | 20         | DADP1            |        |        |         |         |
| 26          | 21         | DADM1            |        |        |         |         |
| 27          | 22         | AD5              |        |        |         |         |
| 28          | 23         | DADP2            |        |        |         |         |
| 29          | 24         | DADM2            |        |        |         |         |
| 30          | 25         | AD6              |        |        |         |         |
| 31          | _          | DADP3            |        |        |         |         |
| 32          | _          | DADM3            |        |        |         |         |

MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3



Table 4. MCF51EM256 Series Package Pin Assignments (continued)

| 100<br>LQFP | 80<br>LQFP | Default Function  | ALT1   | ALT2       | ALT3 | Comment   |
|-------------|------------|-------------------|--------|------------|------|---|
| 33          | _          | AD7               |        |            |      |   |
| 34          | 26         | V <sub>REFO</sub> |        |            |      |   |
| 35          | 27         | V <sub>REFL</sub> |        |            |      |   |
| 36          | 28         | V <sub>SSA</sub>  |        |            |      |   |
| 37          | 29         | EXTAL1            |        |            |      |   |
| 38          | 30         | XTAL1             |        |            |      |   |
| 39          | 31         | $V_{BAT}$         |        |            |      |   |
| 40          | 32         | TAMPER            |        |            |      |   |
| 41          | 33         | PTA0/RGPIO0       | IRQ    | CLKOUT     |      |   |
| 42          | _          | PTE0              |        | PRACMP10   | AD8  |   |
| 43          | _          | PTE1              |        | PRACMP1P3  | AD9  |   |
| 44          | 34         | PTA1/RGPIO1       | MOSI1  |            |      |   |
| 45          | 35         | PTA2/RGPIO2       | MISO1  |            | AD10 |   |
| 46          | 36         | PTA3/RGPIO3       | SCLK1  |            |      | RGPIO_ENB is used to select   |
| 47          | 37         | PTA4/RGPIO4       | SS1    |            |      | between standard GPIO and   |
| 48          | 38         | PTA5/RGPIO5       | TPMCH0 |            | AD11 | RGPIO   |
| 49          | 39         | PTA6/RGPIO6       | TPMCH1 |            | AD12 |   |
| 50          | 40         | PTA7/RGPIO7       | TPMCLK | PRACMP1P2  | AD13 |   |
| 51          | _          | PTE2              |        | PRACMP1P1  |      |   |
| 52          | 41         | PTB0/RGPIO8       | KBI1P0 | PRACMP2P0  | RX2  | RGPIO_ENB is used to select<br>between standard GPIO and<br>RGPIO           |
| 53          | 42         | PTB1/RGPIO9       | KBI1P1 | <u>SS3</u> | TX2  | 2X Drive Output RGPIO_ENB is used to select between standard GPIO and RGPIO |
| 54          | 43         | V <sub>DD</sub>   |        |            |      |   |
| 55          | 44         | V <sub>SS</sub>   |        |            |      |   |
| 56          | 45         | PTB2/RGPIO10      | KBI1P2 | PRACMP1P0  | RX1  | RGPIO_ENB is used to select<br>between standard GPIO and<br>RGPIO           |
| 57          | 46         | PTB3/RGPIO11      | KBI1P3 | PRACMP2P1  | TX1  | 2X drive output RGPIO_ENB is used to select between standard GPIO and RGPIO |





Table 4. MCF51EM256 Series Package Pin Assignments (continued)

| 100<br>LQFP     | 80<br>LQFP      | Default Function | ALT1   | ALT2      | ALT3      | Comment  |
|-----------------|-----------------|------------------|--------|-----------|-----------|--|
| 58              | 47              | PTB4/RGPIO12     | SCL    | PRACMP2P2 |           | RGPIO_ENB is used to select  |
| 59              | 48              | PTB5/RGPIO13     | SDA    | PRACMP2P3 |           | between standard GPIO and<br>RGPIO   |
| 60              | _               | PTE3             | MOSI3  | MISO3     |           |  |
| 61              | _               | PTE4             | MISO3  | MOSI3     |           | Open Drain   |
| 62              | _               | PTE5             | SCLK3  |           |           | Open Drain   |
| 63              | _               | PTE6             | SS3    | TX2       |           | Open Drain   |
| 64              | 49              | PTB6/RGPIO14     | KBI1P4 | TMRCLK1   | AD14      | RGPIO_ENB is used to select  |
| 65              | 50              | PTB7/RGPIO15     | KBI1P5 | TMRCLK2   | AD15      | between standard GPIO and<br>RGPIO   |
| 66              | 51              | RESET            |        |           |           | This pin is an open drain device and has an internal pullup. There is no clamp diode to $V_{DD}$ . |
| 67              | 52              | PTC0             | KBI1P6 | EXTAL2    | RX3       |  |
| 68              | 53              | PTC1             | KBI1P7 | XTAL2     | TX3       |  |
| 69              | 54              | BKGD/MS          | PTC2   |           |           | This pin has an internal pullup.<br>PTC2 can only be programmed as<br>an output.                   |
| 70 <sup>1</sup> | 55 <sup>1</sup> | PTC3             | LCD0   | PRACMP10  |           |  |
| 71 <sup>1</sup> | 56 <sup>1</sup> | PTC4             | LCD1   | PRACMP2O  |           |  |
| 72 <sup>1</sup> | 57 <sup>1</sup> | PTC5             | LCD2   |           | PRACMP1P4 |  |
| 73 <sup>1</sup> | 58 <sup>1</sup> | PTC6             | LCD3   |           | PRACMP2P4 |  |
| 74 <sup>1</sup> | 59 <sup>1</sup> | PTC7             | LCD4   |           |           |  |
| 75 <sup>1</sup> | 60 <sup>1</sup> | PTE7             | LCD5   |           |           |  |
| 76 <sup>1</sup> | 61 <sup>1</sup> | LCD6             | MOSI2  |           |           |  |
| 77 <sup>1</sup> | 62 <sup>1</sup> | LCD7             | MISO2  |           |           |  |
| 78 <sup>1</sup> | 63 <sup>1</sup> | LCD8             | SCLK2  |           |           |  |
| 79 <sup>1</sup> | 64 <sup>1</sup> | LCD9             | SS2    |           |           |  |
| 80              | 65              | LCD10            |        |           |           |  |
| 81              | 66              | LCD11            |        |           |           |  |
| 82              | 67              | LCD12            |        |           |           |  |
| 83              | 68              | LCD13            |        |           |           |  |
| 84              | 69              | LCD14            |        |           |           |  |
| 85              | 70              | LCD15            |        |           |           |  |
| 86              | _               | LCD16            |        |           |           |  |



Table 4. MCF51EM256 Series Package Pin Assignments (continued)

| 100<br>LQFP | 80<br>LQFP | Default Function | ALT1 | ALT2 | ALT3 | Comment |
|-------------|------------|------------------|------|------|------|---------|
| 87          | _          | LCD17            |      |      |      |         |
| 88          | _          | LCD18            |      |      |      |         |
| 89          | _          | LCD19            |      |      |      |         |
| 90          | _          | LCD20            |      |      |      |         |
| 91          | 71         | LCD21            |      |      |      |         |
| 92          | 72         | LCD22            |      |      |      |         |
| 93          | 73         | LCD23            |      |      |      |         |
| 94          | 74         | LCD24            |      |      |      |         |
| 95          | 75         | V <sub>SS</sub>  |      |      |      |         |
| 96          | 76         | VLL3             |      |      |      |         |
| 97          | 77         | VLL2             |      |      |      |         |
| 98          | 78         | VLL1             |      |      |      |         |
| 99          | 79         | VCAP2            |      |      |      |         |
| 100         | 80         | VCAP1            |      |      |      |         |

These pins that are shared with the LCD are open-drain by default if not used as LCD pins. To configure this pins as full complementary drive outputs, you must have the LCD modules bits configured as follow: FCDEN =1, VSUPPLY = 11 and RVEN = 0. The Input levels and internal pullup resistors are referenced to VLL3. Referer to the LCD chapter for further information.

## 2 Electrical Characteristics

This section contains electrical specification tables and reference timing diagrams for the MCF51EM256/128 series microcontrollers, including detailed information on power considerations, DC/AC electrical characteristics, and AC timing specifications.

The electrical specifications are preliminary and are from previous designs or design simulations. These specifications may not be fully tested or guaranteed at this early stage of the product life cycle. These specifications will, however, be met for production silicon. Finalized specifications will be published after complete characterization and device qualifications have been completed.

#### NOTE

The parameters specified in this data sheet supersede any values found in the module specifications.

## 2.1 Parameter Classification

The electrical parameters shown in this supplement are guaranteed by various methods. To give the customer a better understanding the following classification is used and the parameters are tagged accordingly in the tables where appropriate:



#### **Table 5. Parameter Classifications**

| Р | Those parameters are guaranteed during production testing on each individual device.   |
|---|--|
| С | Those parameters are achieved by the design characterization by measuring a statistically relevant sample size across process variations.  |
| Т | Those parameters are achieved by design characterization on a small sample size from typical devices under typical conditions unless otherwise noted. All values shown in the typical column are within this category. |
| D | Those parameters are derived mainly from simulations.  |

#### NOTE

The classification is shown in the column labeled "C" in the parameter tables where appropriate.

## 2.2 Absolute Maximum Ratings

Absolute maximum ratings are stress ratings only, and functional operation at the maxima is not guaranteed. Stress beyond the limits specified in Table 6 may affect device reliability or cause permanent damage to the device. For functional operating conditions, refer to the remaining tables in this section.

This device contains circuitry protecting against damage due to high static voltage or electrical fields; however, it is advised that normal precautions be taken to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate logic voltage level (for instance, either  $V_{SS}$  or  $V_{DD}$ ).

| Rating  | Symbol           | Value                    | Unit |
|---|------------------|--------------------------|------|
| Supply voltage  | $V_{DD}$         | -0.3 to 4.0              | V    |
| Input voltage   | V <sub>In</sub>  | $-0.3$ to $V_{DD} + 0.3$ | V    |
| Instantaneous maximum current Single pin limit (applies to all port pins except PTB1 and PTB3) <sup>1</sup> , <sup>2</sup> , <sup>3</sup> | I <sub>D</sub>   | ±25                      | mA   |
| Instantaneous maximum current<br>Single pin limit (applies to PTB1 and PTB3) <sup>4</sup> , <sup>5</sup> , <sup>6</sup>                   | I <sub>D</sub>   | ±50                      | mA   |
| Maximum current into V <sub>DD</sub>  | I <sub>DD</sub>  | 120                      | mA   |
| Storage temperature   | T <sub>stg</sub> | -55 to 150               | °C   |

**Table 6. Absolute Maximum Ratings** 

Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive  $(V_{DD})$  and negative  $(V_{SS})$  clamp voltages, then use the larger of the two resistance values.

 $<sup>^2</sup>$  All functional non-supply pins are internally clamped to  $\rm V_{SS}$  and  $\rm V_{DD}$ 



- Power supply must maintain regulation within operating V<sub>DD</sub> range during instantaneous and operating maximum current conditions. If positive injection current (V<sub>In</sub> > V<sub>DD</sub>) is greater than I<sub>DD</sub>, the injection current may flow out of V<sub>DD</sub> and could result in external power supply going out of regulation. Ensure external V<sub>DD</sub> load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power. Examples are: if no system clock is present, or if the clock rate is very low which would reduce overall power consumption.
- Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive (V<sub>DD</sub>) and negative (V<sub>SS</sub>) clamp voltages, then use the larger of the two resistance values.
- $^{5}$  All functional non-supply pins are internally clamped to  $\rm V_{SS}$  and  $\rm V_{DD}$ .
- Power supply must maintain regulation within operating V<sub>DD</sub> range during instantaneous and operating maximum current conditions. If positive injection current (V<sub>In</sub> > V<sub>DD</sub>) is greater than I<sub>DD</sub>, the injection current may flow out of V<sub>DD</sub> and could result in external power supply going out of regulation. Ensure external V<sub>DD</sub> load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power. Examples are: if no system clock is present, or if the clock rate is very low which would reduce overall power consumption.

### 2.3 Thermal Characteristics

This section provides information about operating temperature range, power dissipation, and package thermal resistance. Power dissipation on I/O pins is usually small compared to the power dissipation in on-chip logic and it is user-determined rather than being controlled by the MCU design. In order to take  $P_{I/O}$  into account in power calculations, determine the difference between actual pin voltage and  $V_{SS}$  or  $V_{DD}$  and multiply by the pin current for each I/O pin. Except in cases of unusually high pin current (heavy loads), the difference between pin voltage and  $V_{SS}$  or  $V_{DD}$  will be very small.

**Table 7. Thermal Characteristics** 

| Rating   |            | Symbol            | Value     | Unit |
|--|------------|-------------------|-----------|------|
| Operating temperature range (packaged)             |            | T <sub>A</sub>    | -40 to 85 | °C   |
| Maximum junction temperature                       |            | $T_JM$            | 95        | °C   |
| Thermal resistance <sup>1,2,3,4</sup> 100-pin LQFP |            |                   |           |      |
| 80-pin LQFP  | 1s<br>2s2p | $\theta_{\sf JA}$ | 54<br>42  | °C/W |
| 33 p = 4   | 1s<br>2s2p |                   | 55<br>42  |      |

Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.

The average chip-junction temperature (T<sub>I</sub>) in °C can be obtained from:

<sup>&</sup>lt;sup>2</sup> Junction to Ambient Natural Convection

<sup>&</sup>lt;sup>3</sup> 1s — Single layer board, one signal layer

<sup>&</sup>lt;sup>4</sup> 2s2p — Four layers board, two signal and two power layers



$$T_{J} = T_{A} + (P_{D} \times \theta_{JA})$$
 Eqn. 1

where:

 $T_A = Ambient temperature, °C$ 

 $\theta_{IA}$  = Package thermal resistance, junction-to-ambient, °C/W

 $P_D = P_{int} + P_{I/O}$ 

 $P_{int} = I_{DD} \times V_{DD}$ , Watts — chip internal power

P<sub>I/O</sub> = Power dissipation on input and output pins — user determined

For most applications,  $P_{I/O} \ll P_{int}$  and can be neglected. An approximate relationship between  $P_D$  and  $T_J$  (if  $P_{I/O}$  is neglected) is:

$$P_D = K \div (T_J + 273^{\circ}C)$$
 Eqn. 2

Solving Equation 1 and Equation 2 for K gives:

$$K = P_D \times (T_\Delta + 273^{\circ}C) + \theta_{A\Delta} \times (P_D)^2$$
 Eqn. 3

where K is a constant pertaining to the particular part. K can be determined from Equation 3 by measuring  $P_D$  (at equilibrium) for a known  $T_A$ . Using this value of K, the values of  $P_D$  and  $T_J$  can be obtained by solving Equation 1 and Equation 2 iteratively for any value of  $T_A$ .

## 2.4 Electrostatic Discharge (ESD) Protection Characteristics

Although damage from static discharge is much less common on these devices than on early CMOS circuits, normal handling precautions should be used to avoid exposure to static discharge. Qualification tests are performed to ensure that these devices can withstand exposure to reasonable levels of static without suffering any permanent damage.

All ESD testing is in conformity with CDF-AEC-Q00 Stress Test Qualification for Automotive Grade Integrated Circuits. (http://www.aecouncil.com/) This device was qualified to AEC-Q100 Rev E.

A device is considered to have failed if, after exposure to ESD pulses, the device no longer meets the device specification requirements. Complete dc parametric and functional testing is performed per the applicable device specification at room temperature followed by hot temperature, unless specified otherwise in the device specification.

**Table 8. ESD and Latch-up Test Conditions** 

| Model               | Description                 | Symbol | Value | Unit |
|---------------------|-----------------------------|--------|-------|------|
| Human Body          | Series Resistance           | R1     | 1500  | Ω    |
| Storage Capacitance |                             | С      | 100   | pF   |
|                     | Number of Pulse per pin     | _      | 3     |      |
| Machine             | Series Resistance           | R1     | 0     | Ω    |
|                     | Storage Capacitance         | С      | 200   | pF   |
|                     | Number of Pulse per pin     | _      | 3     |      |
| Latch-up            | Minimum input voltage limit |        | -2.5  | ٧    |
|                     | Maximum input voltage limit |        | 7.5   | ٧    |

MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3



**Table 9. ESD and Latch-Up Protection Characteristics** 

| Num | Rating                                     | Symbol           | Min   | Max | Unit |
|-----|--|------------------|-------|-----|------|
| 1   | Human Body Model (HBM)                     | V <sub>HBM</sub> | ±2000 | _   | V    |
| 2   | Machine Model (MM)                         | $V_{MM}$         | ±200  | _   | V    |
| 3   | Charge Device Model (CDM)                  | V <sub>CDM</sub> | ±500  | _   | V    |
| 4   | Latch-up Current at T <sub>A</sub> = 85 °C | I <sub>LAT</sub> | ±100  | _   | mA   |

## 2.5 DC Characteristics

This section includes information about power supply requirements, I/O pin characteristics, and power supply current in various operating modes.

**Table 10. DC Characteristics** 

| Num | С      |                        | Parameter   | Symbol           | Min                   | Typical <sup>1</sup> | Max  | Unit |
|-----|--------|------------------------|---|------------------|-----------------------|----------------------|------|------|
|     |        | Operating              | Digital supply — 50 MHz operation   | $V_{DD}$         | 2.5                   | _                    | 3.6  |      |
| 1   | Р      | Operating voltage      | Digital supply <sup>2</sup> — 20 MHz maximum operation  | V <sub>DD</sub>  | 1.8                   | _                    | 3.6  | V    |
| 2   | Р      | Analog supply          |   | $V_{DDA}$        | 1.8                   | _                    | 3.6  | V    |
| 3   | D      | Battery supply         |   |                  | 2.2                   | 3                    | 3.3  | V    |
| 4   | Р      | Bandgap volta          | ge reference <sup>3</sup>   | $V_{BG}$         | 1.15                  | 1.17                 | 1.18 | V    |
| 5   | C<br>P | Output high voltage    | $\label{eq:ptopology} \begin{array}{l} \mbox{PTA}[7:0], \mbox{PTB}[7:0], \mbox{PTC}[2:0], \mbox{PTE}[6:0], \\ \mbox{low-drive strength.} \\ \mbox{V}_{DD} \geq 1.8 \mbox{ V, } \mbox{I}_{Load} = -0.6 \mbox{ mA} \\ \mbox{PTA}[7:0], \mbox{PTB}[7:0], \mbox{PTC}[2:0], \mbox{PTE}[6:0], \\ \mbox{high-drive strength.} \\ \mbox{V}_{DD} \geq 2.7 \mbox{ V, } \mbox{I}_{Load} = -10 \mbox{ mA} \\ \mbox{PTA}[7:0], \mbox{PTB}[7:0], \mbox{PTC}[2:0], \mbox{PTE}[6:0], \\ \mbox{high-drive strength.} \\ \mbox{V}_{DD} \geq 1.8 \mbox{ V, } \mbox{I}_{Load} = -3 \mbox{ mA} \\ \end{array}$ | V <sub>OH</sub>  | V <sub>DD</sub> – 0.5 |                      | _    | V    |
| 6   | C P    | Output high<br>voltage | PTC[7:3], PTD[7:0], PTE7, PTF[7:0], LCD35/CLKOUT, MOSI2, MISO2, SCK2, SS2, low drive strength. VDD ≥ 1.8 V, $I_{Load} = -0.5$ mA PTC[7:3], PTD[7:0], PTE7, PTF[7:0], LCD35/CLKOUT, MOSI2, MISO2, SCK2, SS2, high-drive strength. $V_{DD} \ge 2.7$ V, $I_{Load} = -3$ mA PTC[7:3], PTD[7:0], PTE7, PTF[7:0], LCD35/CLKOUT, MOSI2, MISO2, SCK2, SS2, high-drive strength. $V_{DD} \ge 1.8$ V, $I_{Load} = -1$ mA  | V <sub>OH</sub>  | V <sub>DD</sub> – 0.5 |                      | _    | V    |
| 7   | D      | Output high current    | Max total I <sub>OH</sub> for all ports   | I <sub>OHT</sub> | _                     | _                    | 100  | mA   |



## **Table 10. DC Characteristics (continued)**

| Num | С      |  | Parameter   | Symbol             | Min                    | Typical <sup>1</sup> | Max                  | Unit        |  |
|-----|--------|--|---|--------------------|------------------------|----------------------|----------------------|-------------|--|
| 8   | C<br>P | Output low<br>voltage                            | $\label{eq:ptopology} \begin{array}{l} \text{PTA}[7:0],  \text{PTB}[7:0],  \text{PTC}[2:0],  \text{PTE}[6:0], \\ \text{low-drive strength.} \\ V_{DD} \geq 1.8  \text{V},  I_{Load} = 2  \text{mA} \\ \\ \text{PTA}[7:0],  \text{PTB}[7:0],  \text{PTC}[2:0],  \text{PTE}[6:0], \\ \text{high-drive strength.} \\ V_{DD} \geq 2.7  \text{V},  I_{Load} = 10  \text{mA} \\ \\ \text{PTA}[7:0],  \text{PTB}[7:0],  \text{PTC}[2:0],  \text{PTE}[6:0], \\ \text{high-drive strength.} \\ V_{DD} \geq 1.8  \text{V},  I_{Load} = 3  \text{mA} \\ \end{array}$ | V <sub>OL</sub>    | _                      |                      | 0.50                 | <b>&gt;</b> |  |
| 9   | C<br>P | Output low voltage                               | PTC[7:3], PTD[7:0], PTE7, PTF[7:0], LCD35/CLKOUT, MOSI2, MISO2, SCK2, SS2, low drive strength. VDD $\geq$ 1.8 V, I <sub>Load</sub> = 0.5 mA PTC[7:3], PTD[7:0], PTE7, PTF[7:0], LCD35/CLKOUT, MOSI2, MISO2, SCK2, SS2, high-drive strength. V <sub>DD</sub> $\geq$ 2.7 V, I <sub>Load</sub> = 3 mA  | V <sub>OL</sub>    | _                      | _                    | 0.50                 | V           |  |
|     | С      |  | PTC[7:3], PTD[7:0], PTE7, PTF[7:0], LCD35/CLKOUT, MOSI2, MISO2, SCK2, SS2, high-drive strength. $V_{DD} \ge 1.8 \text{ V}, I_{Load} = 1 \text{ mA}$   |                    |                        |                      |                      |             |  |
| 10  | D      | Output low current                               | Max total I <sub>OL</sub> for all ports   | I <sub>OLT</sub>   | _                      |                      | 100                  | mA          |  |
|     |        | la a de la   | All digital inputs except tamper_in, V <sub>DD</sub> > 2.7 V  |                    | 0.70 × V <sub>DD</sub> | _                    | _                    |             |  |
| 11  | Р      | Input high voltage                               | All digital inputs except tamper_in, 2.7 V > $V_{DD} \ge 1.8 \text{ V}$   | V <sub>IH</sub>    | $0.85 \times V_{DD}$   | _                    | _                    | ٧           |  |
|     |        |  | Tamper_in   |                    | 1.5                    | _                    | _                    |             |  |
|     |        | Input low  | All digital inputs except tamper_in, $V_{DD} > 2.7 \text{ V}$   |                    | _                      | 1                    | $0.35 \times V_{DD}$ |             |  |
| 12  | Р      | Input low<br>voltage                             | all digital inputs except tamper_in, 2.7 V > $V_{DD} \ge 1.8 \text{ V}$   | V <sub>IL</sub>    | _                      | _                    | $0.3 \times V_{DD}$  | V           |  |
|     |        |  | Tamper_in   |                    |                        | _                    | 0.5                  |             |  |
| 13  |        |  | is; all digital inputs  | V <sub>hys</sub>   | $0.06 \times V_{DD}$   | _                    | _                    | mV          |  |
| 14  | Р      | Input leakage                                    | current; input only pins <sup>4</sup>   | II <sub>In</sub> I | _                      | 0.1                  | 1                    | μΑ          |  |
| 15  | Р      | •  | ce (off-state) leakage current <sup>4</sup>   | ll <sub>OZ</sub> l | _                      | 0.1                  | 1                    | μΑ          |  |
| 16  | Р      | Internal pullup                                  |   | R <sub>PU</sub>    | 17.5                   |                      | 52.5                 | kΩ          |  |
| 17  | Р      | Internal pulldown resistors <sup>6</sup>         |   | R <sub>PD</sub>    | 17.5                   | _                    | 52.5                 | kΩ          |  |
| 18  | С      | Input capacitance; all non-supply pins           |   | C <sub>In</sub>    | _                      | _                    | 8                    | pF          |  |
| 19  | Р      | POR rearm voltage                                |   | V <sub>POR</sub>   | 0.9                    | 1.4                  | 2.0                  | V           |  |
| 20  | D      | POR rearm tir                                    | ne  | t <sub>POR</sub>   | 10                     | _                    | _                    | μS          |  |
| 6.1 |        | Low-voltage High range — V <sub>DD</sub> falling |   | .,                 | 2.300                  | 2.355                | 2.410                |             |  |
| 21  | Р      | detection<br>threshold                           | High range — V <sub>DD</sub> rising   | V <sub>LVDH</sub>  | 2.370                  | 2.425                | 2.480                | V           |  |

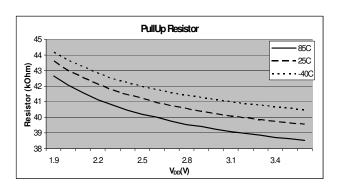


Table 10. DC Characteristics (continued)

| Num | С    |   | Parameter                           | Symbol            | Min        | Typical <sup>1</sup> | Max   | Unit |
|-----|------|---|-------------------------------------|-------------------|------------|----------------------|-------|------|
|     | _    | Low-voltage   | Low range — V <sub>DD</sub> falling | .,                | 1.800      | 1.845                | 1.890 | V    |
| 22  | 22 C | detection<br>threshold  | Low range — V <sub>DD</sub> rising  | V <sub>LVDL</sub> | 1.870      | 1.915                | 1.960 | ٧    |
|     | 1    | Low-voltage   | V <sub>DD</sub> falling, LVWV = 1   | .,                | 2.590      | 2.655                | 2.720 | .,   |
| 23  |      | warning<br>threshold  | V <sub>DD</sub> rising, LVWV = 1    | $V_{LVWH}$        | 2.580      | 2.645                | 2.710 | V    |
| 24  | C    | Low-voltage warning   | $V_{DD}$ falling, LVWV = 0          | V <sub>LVWL</sub> | 2.300      | 2.355                | 2.410 | V    |
| 24  |      |   | $V_{DD}$ rising, LVWV = 0           | V LVWL            | 2.360      | 2.425                | 2.490 | V    |
| 25  | D    | RAM retention   | •                                   | V <sub>RAM</sub>  | _          | 0.6                  | 1.0   | V    |
| 26  |      | DC injection current <sup>7 8 9 10</sup> (single pin limit), $V_{IN} > V_{DD}$ , $V_{IN} < V_{SS}$ DC injection current (Total MCU limit, includes sum of all stressed pins), $V_{IN} > V_{DD}$ , $V_{IN} < V_{SS}$ |                                     | lio               | -0.2       | _                    | 0.2   | mA   |
| 20  |      |   |                                     | I <sub>IC</sub>   | <b>-</b> 5 | _                    | 5     | mA   |

Typical values are based on characterization data at 25 °C unless otherwise stated.

<sup>&</sup>lt;sup>10</sup> The  $\overline{\text{RESET}}$  pin does not have a clamp diode to  $V_{DD}$ . Do not drive this pin above  $V_{DD}$ .



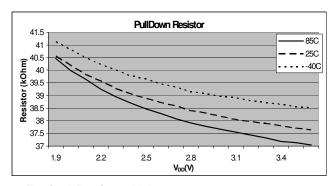


Figure 4. Pullup and Pulldown Typical Resistor Values

<sup>&</sup>lt;sup>2</sup> Switch to lower frequency when the low-voltage interrupt asserts (V<sub>LVDH</sub>).

Factory trimmed at V<sub>DD</sub> = 3.0 V, Temp = 25°C

<sup>&</sup>lt;sup>4</sup> Measured with  $V_{In} = V_{DD}$  or  $V_{SS}$ .

<sup>&</sup>lt;sup>5</sup> Measured with  $V_{ln} = V_{SS}$ .

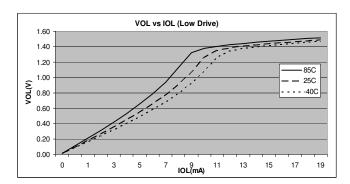
<sup>&</sup>lt;sup>6</sup> Measured with  $V_{In} = V_{DD}$ .

Power supply must maintain regulation within operating V<sub>DD</sub> range during instantaneous and operating maximum current conditions. If positive injection current (V<sub>In</sub> > V<sub>DD</sub>) is greater than I<sub>DD</sub>, the injection current may flow out of V<sub>DD</sub> and could result in external power supply going out of regulation. Ensure external V<sub>DD</sub> load will shunt current greater than maximum injection current. This will be the greatest risk when the MCU is not consuming power. Examples are: if no system clock is present, or if clock rate is very low (which would reduce overall power consumption).

 $<sup>^8</sup>$  All functional non-supply pins are internally clamped to  $V_{SS}$  and  $V_{DD}$ .

Input must be current limited to the value specified. To determine the value of the required current-limiting resistor, calculate resistance values for positive and negative clamp voltages, then use the larger of the two values.





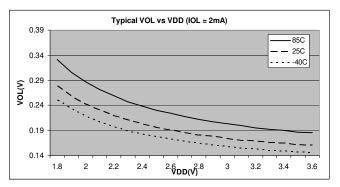
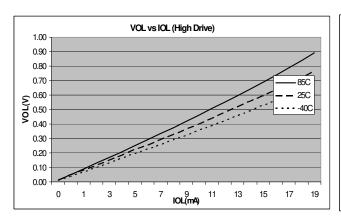


Figure 5. Typical Low-Side Driver (Sink) Characteristics — Low Drive (PTxDSn = 0)



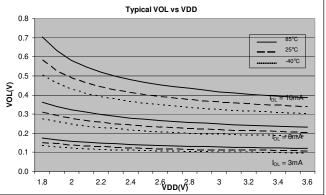
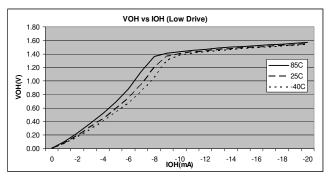


Figure 6. Typical Low-Side Driver (Sink) Characteristics — High Drive (PTxDSn = 1)



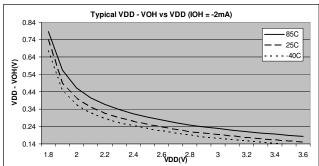
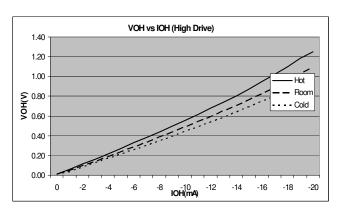


Figure 7. Typical High-Side (Source) Characteristics — Low Drive (PTxDSn = 0)





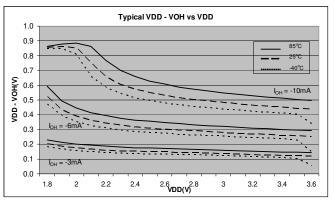


Figure 8. Typical High-Side (Source) Characteristics — High Drive (PTxDSn = 1)

## 2.6 Supply Current Characteristics

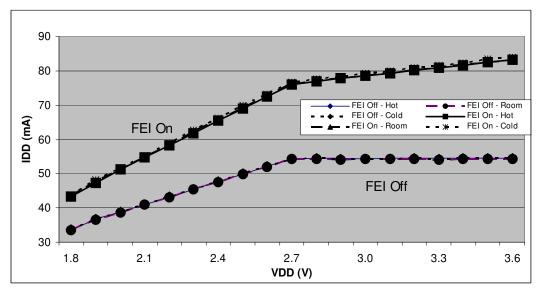


Figure 9. Typical Run  $I_{DD}$  for FBE and FEI,  $I_{DD}$  vs.  $V_{DD}$  (All Modules Enabled)



**Table 11. Supply Current Characteristics** 

| Num | С | Parame   | ter                   | Symbol               | V <sub>DD</sub> (V) | Typical <sup>1</sup> | Max    | Unit                | Temp<br>(°C) |
|-----|---|--|-----------------------|----------------------|---------------------|----------------------|--------|---------------------|--------------|
|     | Р |  | 25.165 MHz            |                      |                     | 66.2                 | 100    |                     |              |
| 1   | Т | Run supply current<br>FEI mode, all  | 20 MHz                | DI                   | 3                   | 55.3                 | _      | mA                  | -40 to       |
| 1   | Т | modules on   | 8 MHz                 | RI <sub>DD</sub>     | 3                   | 23.9                 | _      | IIIA                | 85°C         |
|     | Т |  | 1 MHz                 |                      |                     | 4.56                 | _      |                     |              |
|     | С |  | 25.165 MHz            |                      |                     | 55.1                 | 56     |                     |              |
| 0   | Т | Run supply current   | 20 MHz                | DI                   | 0                   | 46.6                 | _      | A                   | -40 to       |
| 2   | Т | FEI mode, all modules off  | 8 MHz                 | RI <sub>DD</sub>     | 3                   | 19.9                 | _      | - mA                | 85°C         |
|     | Т |  | 1 MHz                 | •                    |                     | 3.92                 | _      | 1                   |              |
|     | Т | Run supply current   | 16 kHz FBILP          |                      |                     | 239                  | _      |                     |              |
| 3   | Т | LPS=0, all modules off   | 16 kHz<br>FBELP       | RI <sub>DD</sub>     | 3                   | 249                  | _      | μΑ                  | _            |
| 4   | Т | Run supply current<br>LPS = 1, all<br>modules off,<br>running from flash   | 16 kHz<br>FBELP       | RI <sub>DD</sub>     | 3                   | 50                   | _      | μА                  | _            |
|     | С | Wait mode supply   | 25.165 MHz            |                      |                     | 51.1                 | 69     |                     |              |
| 5   | Т | current  | 20 MHz                | \\/!                 | 9                   | 42.6                 | _      | m A                 | -40 to       |
| 5   | Т | FEI mode, all  | 8 MHz                 | WI <sub>DD</sub>     | 3                   | 18.8                 | _      | - mA                | 85°C         |
|     | Т | modules off  | 1                     |                      |                     | 3.69                 | 3.69 — |                     |              |
| 6   | Т | Wait mode supply cu<br>LPRS = 1, all mods of   |                       | WI <sub>DD</sub>     | 3                   | 1                    | _      | μА                  | _            |
| 7   | Р | Ctan O made augustu a  | urront                | S2I <sub>DD</sub>    | 3                   | 0.576                | 30     | μΑ                  | -40 to       |
| 1   | С | Stop2 mode supply c  | urreni                | DD                   | 2                   | 0.576                | 16     | 1                   | 85°C         |
| 8   | Р | 040  |                       | 001                  | 3                   | 4.05                 | 45     | ۸                   | -40 to       |
|     | С | Stop3 mode supply c  | urrent                | S3I <sub>DD</sub>    | 2                   | 1.05                 | 27     | <b>-</b> μ <b>A</b> | 85°C         |
| 9   | Т | LVD adder to stop3, s<br>LVDSE = 1)  | stop2 (LVDE =         | S3I <sub>DDLVD</sub> | 3                   | 120                  | _      | μА                  | _            |
|     |   | Voltage reference  | Low power mode        |                      |                     | 90                   |        |                     |              |
| 10  | Т | adder to stop3   | Tight regulation mode | S3I <sub>DDLVD</sub> | 3                   | 270                  | _      | μА                  | _            |
| 11  | Т | PRACMP adder to  | PRG disabled          | COL                  | 9                   | 13                   |        | ^                   |              |
| 11  | ' | stop3  | PRG enabled           | S3I <sub>DDLVD</sub> | 3                   | 29                   | _      | μА                  |              |
| 12  | Т | LCD adder to stop3, stop2, VIREG enabled, 1/4 duty cycle, 4x39 configuration for 156 segments, 32Hz frame rate, no LCD glass connected |                       | S3I <sub>DDLVD</sub> | 3                   | 1.3                  | _      | μА                  | _            |
| 13  | С | Adder to stop3 for oso<br>(ERCLKEN =1 and E  |                       | S3I <sub>DDOSC</sub> | 3                   | 5                    |        | μА                  | _            |

MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3



**Table 11. Supply Current Characteristics (continued)** 

| Num | С | Parameter                            | Symbol              | V <sub>DD</sub> (V) | Typical <sup>1</sup> | Max | Unit | Temp<br>(°C)   |
|-----|---|--------------------------------------|---------------------|---------------------|----------------------|-----|------|----------------|
| 14  | Р | IRTC supply current <sup>3,4,5</sup> | I <sub>DD-BAT</sub> |                     | 1.5                  | 5   | μА   | −40 to<br>85°C |

<sup>&</sup>lt;sup>1</sup> Typicals are measured at 25 °C.

<sup>&</sup>lt;sup>2</sup> Values given under the following conditions: low range operation (RANGE = 0), low power mode (HGO = 0).

 $<sup>^{3}\,</sup>$  This is the current consumed when the IRTC is being powered by the  $V_{BAT}$ 

<sup>&</sup>lt;sup>4</sup> The IRTC power source depends on the MCU configuration and V<sub>DD</sub> voltage level. Refer to reference manual for further information.

<sup>&</sup>lt;sup>5</sup> The IRTC current consumption includes the IRTC XOSC1.



## 2.7 Analog Comparator (PRACMP) Electricals

**Table 12. PRACMP Electrical Specifications** 

| N  | С | Characteristic                                 | Symbol              | Min                   | Typical  | Max             | Unit |
|----|---|--|---------------------|-----------------------|----------|-----------------|------|
| 1  | _ | Supply voltage                                 | V <sub>PWR</sub>    | 1.8                   | _        | 3.6             | V    |
| 2  | С | Supply current (active) (PRG enabled)          | I <sub>DDACT1</sub> | _                     | _        | 60              | μА   |
| 3  | С | Supply current (active) (PRG disabled)         | I <sub>DDACT2</sub> | _                     | _        | 40              | μА   |
| 4  | D | Supply current (ACMP and PRG all disabled)     | I <sub>DDDIS</sub>  | _                     | _        | 2               | nA   |
| 5  | _ | Analog input voltage                           | VAIN                | V <sub>SS</sub> - 0.3 | _        | $V_{DD}$        | V    |
| 6  | Т | Analog input offset voltage                    | VAIO                | _                     | 5        | 40              | mV   |
| 7  | Т | Analog comparator hysteresis                   | V <sub>H</sub>      | 3.0                   | _        | 20.0            | mV   |
| 8  | D | Analog input leakage current                   | I <sub>ALKG</sub>   | _                     | _        | 1               | nA   |
| 9  | Т | Analog comparator initialization delay         | t <sub>AINIT</sub>  | _                     | _        | 1.0             | μS   |
| 10 | _ | Programmable reference generator input1        | $V_{In1}(V_{DD})$   | _                     | $V_{DD}$ | _               | V    |
| 11 | Т | Programmable reference generator input2        | $V_{In2}(V_{DD25})$ | 1.8                   | _        | 2.75            | V    |
| 12 | D | Programmable reference generator setup delay   | t <sub>PRGST</sub>  | _                     | 1        | _               | μs   |
| 13 | D | Programmable reference generator step size     | Vstep               | -0.25                 | 0        | 0.25            | LSB  |
| 14 | Р | Programmable reference generator voltage range | V <sub>prgout</sub> | V <sub>In</sub> /32   | _        | V <sub>in</sub> | V    |

## 2.8 ADC Characteristics

These specs all assume seperate  $V_{DDAD}$  supply for ADC and isolated pad segment for ADC supplies and differential inputs. Spec's should be de-rated for  $V_{REFH}$  =  $V_{bg}$  condition.

**Table 13. 16-bit ADC Operating Conditions** 

| Num | Charact eristic        | Conditions   | Symb              | Min  | Typ <sup>1</sup> | Max       | Unit | Comment |
|-----|------------------------|--|-------------------|------|------------------|-----------|------|---------|
| 1   | Supply                 | Absolute   | $V_{DDA}$         | 1.8  | _                | 3.6       | V    |         |
| 2   | - Supply<br>voltage    | Delta to V <sub>DD</sub> (V <sub>DD</sub> -V <sub>DDA</sub> ) <sup>2</sup> | $\Delta V_{DDA}$  | -100 | 0                | 100       | mV   |         |
| 3   | Ground voltage         | Delta to V <sub>SS</sub> (V <sub>SS</sub> -V <sub>SSA</sub> ) <sup>2</sup> | $\Delta V_{SSA}$  | -100 | 0                | 100       | mV   |         |
| 4   | Ref<br>Voltage<br>High |  | V <sub>REFH</sub> | 1.15 | V <sub>DDA</sub> | $V_{DDA}$ | V    |         |



**Table 13. 16-bit ADC Operating Conditions** 

| Num | Charact eristic             | Conditions   | Symb              | Min               | Typ <sup>1</sup> | Max               | Unit | Comment                 |
|-----|-----------------------------|--|-------------------|-------------------|------------------|-------------------|------|-------------------------|
| 5   | Ref<br>Voltage<br>Low       |  | V <sub>REFL</sub> | V <sub>SSA</sub>  | V <sub>SSA</sub> | V <sub>SSA</sub>  | V    |                         |
| 6   | Input<br>Voltage            |  | V <sub>ADIN</sub> | V <sub>REFL</sub> |                  | V <sub>REFH</sub> | ٧    |                         |
| 7   | Input<br>Capacit<br>ance    | 16-bit modes<br>8/10/12-bit modes  | C <sub>ADIN</sub> | _                 | 8<br>4           | 10<br>5           | pF   |                         |
| 8   | Input<br>Resista<br>nce     |  | R <sub>ADIN</sub> | _                 | 2                | 5                 | kΩ   |                         |
| 9   |                             | 16 bit modes  f <sub>ADCK</sub> > 8MHz  4MHz < f <sub>ADCK</sub> < 8MHz  f <sub>ADCK</sub> < 4MHz    |                   | _<br>_<br>_       | _<br>_<br>_      | 0.5<br>1<br>2     |      |                         |
| 10  | Analog<br>Source<br>Resista | 13/12 bit modes $f_{ADCK} > 8MHz$ $4MHz < f_{ADCK} < 8MHz$ $f_{ADCK} < 4MHz$                         | R <sub>AS</sub>   |                   | _<br>_<br>_      | 1<br>2<br>5       | kΩ   | External to MCU Assumes |
| 11  | nce                         | 11/10 bit modes  f <sub>ADCK</sub> > 8MHz  4MHz < f <sub>ADCK</sub> < 8MHz  f <sub>ADCK</sub> < 4MHz |                   |                   |                  | 2<br>5<br>10      |      | ADLSMP=0                |
| 12  |                             | 9/8 bit modes<br>f <sub>ADCK</sub> > 8MHz<br>f <sub>ADCK</sub> < 8MHz                                |                   |                   |                  | 5<br>10           |      |                         |
| 13  | ADC                         | ADLPC = 0, ADHSC = 1   |                   | 1.0               | _                | 8                 |      |                         |
| 14  | Convers<br>ion<br>Clock     | ADLPC = 0, ADHSC = 0   | f <sub>ADCK</sub> | 1.0               | _                | 5                 | MHz  |                         |
| 15  | Freq.                       | ADLPC = 1, ADHSC = 0   |                   | 1.0               | _                | 2.5               |      |                         |

Typical values assume V<sub>DDA</sub> = 3.0 V, Temp = 25 °C, f<sub>ADCK</sub> = 1.0 MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

<sup>&</sup>lt;sup>2</sup> DC potential difference.



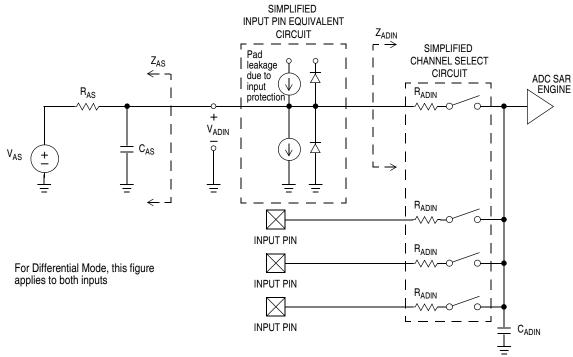


Figure 10. ADC Input Impedance Equivalency Diagram

Table 14. 16-bit ADC Characteristics full operating range( $V_{REFH} = V_{DDAD} > 1.8$ ,  $V_{REFL} = V_{SSAD}$ ,  $F_{ADCK} \le 8MHz$ )

| Characteristic               | Conditions <sup>1</sup>                   | С       | Symb                 | Min | Typ <sup>2</sup> | Max | Unit | Comment                                   |
|------------------------------|---|---------|----------------------|-----|------------------|-----|------|---|
| Supply Current               | ADLPC = 1, ADHSC = 0                      |         | I <sub>DDA</sub>     | _   | 215              | _   |      | ADLOMD O                                  |
|                              | ADLPC = 0, ADHSC = 0                      | Т       |                      | _   | 470              | _   | μА   | ADLSMP = 0<br>ADCO = 1                    |
|                              | ADLPC=0, ADHSC=1                          |         |                      | _   | 610              | _   |      | 1   |
| Supply Current               | Stop, Reset, Module Off                   | С       | I <sub>DDA</sub>     | _   | 0.01             | _   | μА   |   |
| ADC                          | ADLPC = 1, ADHSC = 0                      | Р       | P f <sub>ADACK</sub> | _   | 2.4              | _   |      |   |
| Asynchronous<br>Clock Source | ADLPC = 0, ADHSC = 0                      |         |                      | _   | 5.2              | _   | MHz  | t <sub>ADACK</sub> = 1/f <sub>ADACK</sub> |
|                              | ADLPC = 0, ADHSC = 1                      |         |                      | _   | 6.2              | _   |      |   |
| Sample Time                  | See reference manual for sa               | ımple 1 | times                |     |                  |     | •    |   |
| Conversion<br>Time           | See reference manual for conversion times |         |                      |     |                  |     |      |   |



Table 14. 16-bit ADC Characteristics full operating range( $V_{REFH} = V_{DDAD} > 1.8$ ,  $V_{REFL} = V_{SSAD}$ ,  $F_{ADCK} \le 8MHz$ )

| Characteristic                | Conditions <sup>1</sup>                              | С | Symb            | Min    | Typ <sup>2</sup> | Max                | Unit             | Comment                                |
|-------------------------------|--|---|-----------------|--------|------------------|--------------------|------------------|--|
| Total<br>Unadjusted           | 16-bit differential mode<br>16-bit single-ended mode | Т | TUE             | _<br>_ | ±16<br>±20       | +48/-40<br>+56/-28 | LSB <sup>3</sup> | 32x<br>Hardware                        |
| Error                         | 13-bit differential mode<br>12-bit single-ended mode | Т |                 | _      | ±1.5<br>±1.75    | ±3.0<br>±3.5       |                  | Averaging<br>(AVGE = %1<br>AVGS = %11) |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 | _      | ±0.7<br>±0.8     | ±1.5<br>±1.5       |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _      | ±0.5<br>±0.5     | ±1.0<br>±1.0       |                  |  |
| Differential<br>Non-Linearity | 16-bit differential mode<br>16-bit single-ended mode | Т | DNL             | _      | ±2.5<br>±2.5     | +5/-3<br>+5/-3     | LSB <sup>2</sup> |  |
|                               | 13-bit differential mode<br>12-bit single-ended mode | Т |                 | _      | ±0.7<br>±0.7     | ±1<br>±1           |                  |  |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 | _      | ±0.5<br>±0.5     | ±0.75<br>±0.75     |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _      | ±0.2<br>±0.2     | ±0.5<br>±0.5       |                  |  |
| Integral<br>Non-Linearity     | 16-bit differential mode<br>16-bit single-ended mode | Т | INL             | _      | ±6.0<br>±10.0    | ±16.0<br>±20.0     | LSB <sup>2</sup> |  |
|                               | 13-bit differential mode<br>12-bit single-ended mode | Т |                 | _      | ±1.0<br>±1.0     | ±2.5<br>±2.5       |                  |  |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 | _      | ±0.5<br>±0.5     | ±1.0<br>±1.0       |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _      | ±0.3<br>±0.3     | ±0.5<br>±0.5       |                  |  |
| Zero-Scale<br>Error           | 16-bit differential mode<br>16-bit single-ended mode | Т | E <sub>ZS</sub> | _      | ±4.0<br>±4.0     | +32/-24<br>+24/-16 | LSB <sup>2</sup> | $V_{ADIN} = V_{SSAD}$                  |
|                               | 13-bit differential mode<br>12-bit single-ended mode | Т |                 |        | ±0.7<br>±0.7     | ±2.5<br>±2.0       |                  |  |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 |        | ±0.4<br>±0.4     | ±1.0<br>±1.0       |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _      | ±0.2<br>±0.2     | ±0.5<br>±0.5       |                  |  |



Table 14. 16-bit ADC Characteristics full operating range( $V_{REFH} = V_{DDAD} > 1.8$ ,  $V_{REFL} = V_{SSAD}$ ,  $F_{ADCK} \le 8MHz$ )

| Characteristic                  | Conditions <sup>1</sup>   | С | Symb                | Min                                  | Typ <sup>2</sup>                     | Max                | Unit             | Comment  |
|---------------------------------|---|---|---------------------|--------------------------------------|--------------------------------------|--------------------|------------------|--|
| Full-Scale<br>Error             | 16-bit differential mode<br>16-bit single-ended mode                    | Т | E <sub>FS</sub>     |                                      | +10/0<br>+14/0                       | +42/-2<br>+46/-2   | LSB <sup>2</sup> | $V_{ADIN} = V_{DDAD}$  |
|                                 | 13-bit differential mode<br>12-bit single-ended mode                    | Т |                     | _                                    | ±1.0<br>±1.0                         | ±3.5<br>±3.5       |                  |  |
|                                 | 11-bit differential mode<br>10-bit single-ended mode                    | Т |                     |                                      | ±0.4<br>±0.4                         | ±1.5<br>±1.5       |                  |  |
|                                 | 9-bit differential mode<br>8-bit single-ended mode                      | Т |                     | _                                    | ±0.2<br>±0.2                         | ±0.5<br>±0.5       | -                |  |
| Quantization                    | 16 bit modes  | D | EQ                  | _                                    | -1 to 0                              | _                  | LSB <sup>2</sup> |  |
| Error                           | ≤13 bit modes   |   |                     | _                                    | _                                    | ±0.5               |                  |  |
| Effective<br>Number of Bits     | 16 bit differential mode<br>Avg=32<br>Avg=16<br>Avg=8<br>Avg=4<br>Avg=1 | С | ENOB                | 12.8<br>12.7<br>12.6<br>12.5<br>11.9 | 14.2<br>13.8<br>13.6<br>13.3<br>12.5 | 1111               | Bits             | F <sub>in</sub> =<br>F <sub>sample</sub> /100                            |
|                                 | 16 bit single-ended mode<br>Avg=32<br>Avg=16<br>Avg=8<br>Avg=4<br>Avg=1 | С |                     |                                      | TBD<br>TBD<br>TBD<br>TBD<br>TBD      | <br> -<br> -<br> - |                  |  |
| Signal to Noise plus Distortion | See ENOB  |   | SINAD               | SINAD =                              | = 6.02 · ENC                         | <i>DB</i> + 1. 76  | dB               |  |
| Total Harmonic<br>Distortion    | 16-bit differential mode<br>Avg = 32                                    | С | THD                 | _                                    | -91.5                                | -74.3              | dB               | F <sub>in</sub> = F <sub>sample</sub> /100                               |
|                                 | 16-bit single-ended mode<br>Avg = 32                                    | D |                     | _                                    | -85.5                                | _                  |                  |  |
| Spurious Free<br>Dynamic        | 16-bit differential mode<br>Avg = 32                                    | С | SFDR                | 75.0                                 | 92.2                                 |                    | dB               | F <sub>in</sub> =<br>F <sub>sample</sub> /100                            |
| Range                           | 16-bit single-ended mode<br>Avg = 32                                    | D |                     | _                                    | 86.2                                 | _                  |                  |  |
| Input Leakage<br>Error          | all modes   | D | E <sub>IL</sub>     |                                      | I <sub>In</sub> * R <sub>AS</sub>    |                    | mV               | I <sub>In</sub> = leakage<br>current<br>(refer to DC<br>characteristics) |
| Temp Sensor                     | -40°C– 25°C   | С | m                   | _                                    | 1.646                                | _                  | mV/°C            |  |
| Slope                           | 25°C- 125°C   |   |                     | _                                    | 1.769                                | _                  | 1                |  |
| Temp Sensor<br>Voltage          | 25°C  | С | V <sub>TEMP25</sub> | _                                    | 701.2                                | _                  | mV               |  |

MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3



Table 15. 16-bit ADC Characteristics( $V_{REFH} = V_{DDAD} \ge 2.7V$ ,  $V_{REFL} = V_{SSAD}$ ,  $F_{ADCK} \le 4MHz$ , ADHSC=1)

| Characteristic                | Conditions <sup>1</sup>                              | С | Symb            | Min | Typ <sup>2</sup> | Max                | Unit             | Comment                                |
|-------------------------------|--|---|-----------------|-----|------------------|--------------------|------------------|--|
| Total<br>Unadjusted           | 16-bit differential mode<br>16-bit single-ended mode | Т | TUE             | _   | ±16<br>±20       | +24/-24<br>+32/-20 | LSB <sup>3</sup> | 32x<br>Hardware                        |
| Error                         | 13-bit differential mode<br>12-bit single-ended mode | Т |                 | _   | ±1.5<br>±1.75    | ±2.0<br>±2.5       |                  | Averaging<br>(AVGE = %1<br>AVGS = %11) |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 |     | ±0.7<br>±0.8     | ±1.0<br>±1.25      |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _   | ±0.5<br>±0.5     | ±1.0<br>±1.0       |                  |  |
| Differential<br>Non-Linearity | 16-bit differential mode<br>16-bit single-ended mode | Т | DNL             | _   | ±2.5<br>±2.5     | ±3<br>±3           | LSB <sup>2</sup> |  |
|                               | 13-bit differential mode<br>12-bit single-ended mode | Т |                 |     | ±0.7<br>±0.7     | ±1<br>±1           | LSB <sup>2</sup> |  |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 | _   | ±0.5<br>±0.5     | ±0.75<br>±0.75     |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _   | ±0.2<br>±0.2     | ±0.5<br>±0.5       |                  |  |
| Integral<br>Non-Linearity     | 16-bit differential mode<br>16-bit single-ended mode | Т | INL             | _   | ±6.0<br>±10.0    | ±12.0<br>±16.0     |                  |  |
|                               | 13-bit differential mode<br>12-bit single-ended mode | Т |                 | _   | ±1.0<br>±1.0     | ±2.0<br>±2.0       |                  |  |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 |     | ±0.5<br>±0.5     | ±1.0<br>±1.0       |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _   | ±0.3<br>±0.3     | ±0.5<br>±0.5       |                  |  |
| Zero-Scale<br>Error           | 16-bit differential mode<br>16-bit single-ended mode | Т | E <sub>ZS</sub> | _   | ±4.0<br>±4.0     | +16/0<br>+16/-8    | LSB <sup>2</sup> | V <sub>ADIN</sub> = V <sub>SSAD</sub>  |
|                               | 13-bit differential mode<br>12-bit single-ended mode | Т |                 | _   | ±0.7<br>±0.7     | ±2.0<br>±2.0       |                  |  |
|                               | 11-bit differential mode<br>10-bit single-ended mode | Т |                 | _   | ±0.4<br>±0.4     | ±1.0<br>±1.0       |                  |  |
|                               | 9-bit differential mode<br>8-bit single-ended mode   | Т |                 | _   | ±0.2<br>±0.2     | ±0.5<br>±0.5       |                  |  |

 $<sup>^{\</sup>rm 1}~$  All accuracy numbers assume the ADC is calibrated with  $\rm V_{REFH} = \rm V_{DDAD}$ 

Typical values assume V<sub>DDAD</sub> = 3.0V, Temp = 25°C, f<sub>ADCK</sub> = 2.0 MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

<sup>&</sup>lt;sup>3</sup> 1 LSB =  $(V_{REFH} - V_{REFL})/2^N$ 



Table 15. 16-bit ADC Characteristics( $V_{REFH} = V_{DDAD} \ge 2.7V$ ,  $V_{REFL} = V_{SSAD}$ ,  $F_{ADCK} \le 4MHz$ , ADHSC=1)

| Characteristic                  | Conditions <sup>1</sup>   | С | Symb                | Min                                  | Typ <sup>2</sup>                     | Max                      | Unit             | Comment  |
|---------------------------------|---|---|---------------------|--------------------------------------|--------------------------------------|--------------------------|------------------|--|
| Full-Scale<br>Error             | 16-bit differential mode<br>16-bit single-ended mode                              | Т | E <sub>FS</sub>     |                                      | +8/0<br>+12/0                        | +24/0<br>+24/0           | LSB <sup>2</sup> | $V_{ADIN} = V_{DDAD}$  |
|                                 | 13-bit differential mode<br>12-bit single-ended mode                              | Т |                     | _<br>_                               | ±0.7<br>±0.7                         | ±2.0<br>±2.5             |                  |  |
|                                 | 11-bit differential mode<br>10-bit single-ended mode                              | Т |                     | _                                    | ±0.4<br>±0.4                         | ±1.0<br>±1.0             |                  |  |
|                                 | 9-bit differential mode<br>8-bit single-ended mode                                | Т |                     |                                      | ±0.2<br>±0.2                         | ±0.5<br>±0.5             |                  |  |
| Quantization                    | 16 bit modes  | D | EQ                  | 1                                    | -1 to 0                              | _                        | LSB <sup>2</sup> |  |
| Error                           | ≤13 bit modes   |   |                     | _                                    | _                                    | ±0.5                     |                  |  |
| Effective<br>Number of Bits     | 16 bit differential mode<br>Avg = 32<br>Avg = 16<br>Avg = 8<br>Avg = 4<br>Avg = 1 | С | ENOB                | 14.3<br>13.8<br>13.4<br>13.1<br>12.4 | 14.5<br>14.0<br>13.7<br>13.4<br>12.6 | <br> -<br> -<br> -<br> - | Bits             | F <sub>in</sub> =<br>F <sub>sample</sub> /100                            |
| Signal to Noise plus Distortion | See ENOB  |   | SINAD               | $SINAD = 6.02 \cdot ENOB + 1.76$     |                                      | <i>OB</i> + 1. 76        | dB               |  |
| Total Harmonic<br>Distortion    | 16-bit differential mode<br>Avg = 32  | С | THD                 | _                                    | -95.8                                | -90.4                    | dB               | F <sub>in</sub> =<br>F <sub>sample</sub> /100                            |
|                                 | 16-bit single-ended mode<br>Avg = 32  | D |                     | _                                    | _                                    | _                        |                  |  |
| Spurious Free<br>Dynamic        | 16-bit differential mode<br>Avg = 32  | С | SFDR                | 91.0                                 | 96.5                                 | _                        | dB               | F <sub>in</sub> =<br>F <sub>sample</sub> /100                            |
| Range                           | 16-bit single-ended mode<br>Avg = 32  | D |                     |                                      | _                                    | _                        |                  |  |
| Input Leakage<br>Error          | all modes   | D | E <sub>IL</sub>     |                                      | I <sub>In</sub> * R <sub>AS</sub>    |                          | mV               | I <sub>In</sub> = leakage<br>current<br>(refer to DC<br>characteristics) |
| Temp Sensor                     | -40°C-25°C  | D | m                   | _                                    | 1.646                                | _                        | mV/°C            |  |
| Slope                           | 25°C–125°C  | 1 |                     | _                                    | 1.769                                | _                        |                  |  |
| Temp Sensor<br>Voltage          | 25°C  | D | V <sub>TEMP25</sub> | _                                    | 701.2                                | _                        | mV               |  |

<sup>1</sup> All accuracy numbers assume the ADC is calibrated with V<sub>REFH</sub>=V<sub>DDAD</sub>

Typical values assume V<sub>DDAD</sub> = 3.0 V, Temp = 25 °C, f<sub>ADCK</sub>=2.0MHz unless otherwise stated. Typical values are for reference only and are not tested in production.

<sup>&</sup>lt;sup>3</sup> 1 LSB =  $(V_{REFH} - V_{REFL})/2^N$ 



## 2.9 External Oscillator (XOSC) Characteristics

Reference Figure 11 and Figure 12 for crystal or resonator circuits. XOSC1 operates only in low power low range mode. XOSC2 operates in all the power and range modes.

Table 16. XOSC Specifications (Temperature Range = −40 to 85 °C Ambient)

| Num | С | Characteristic  | Symbol                         | Min              | Typ <sup>1</sup>       | Max              | Unit              |
|-----|---|---|--------------------------------|------------------|------------------------|------------------|-------------------|
| 1   | С | Oscillator crystal or resonator (EREFS = 1, ERCLKEN = 1)  Low range (RANGE = 0)  High range (RANGE = 1), high gain (HGO = 1)  High range (RANGE = 1), low power (HGO = 0)   |                                | 32<br>1<br>1     | _<br>_<br>_            | 38.4<br>16<br>8  | kHz<br>MHz<br>MHz |
| 2   | D | Load capacitors  Low range (RANGE=0), low power (HGO = 0)  Other oscillator settings  | C <sub>1,</sub> C <sub>2</sub> |                  | See N                  |                  |                   |
| 3   | D | Feedback resistor  Low range, low power (RANGE = 0, HGO = 0) <sup>2</sup> Low range, high gain (RANGE = 0, HGO = 1)  High range (RANGE = 1, HGO = X)  | H <sub>F</sub>                 |                  | —<br>10<br>1           | _<br>_<br>_      | МΩ                |
| 4   | D | Series resistor — Low range, low power (RANGE = 0, HGO = 0) <sup>2</sup> Low range, high gain (RANGE = 0, HGO = 1) High range, low power (RANGE = 1, HGO = 0) High range, high gain (RANGE = 1, HGO = 1)  ≥ 8 MHz 4 MHz 1 MHz |                                | _<br>_<br>_<br>_ | <br>0<br>100<br>0<br>0 |                  | kΩ                |
| 5   | Т | Crystal start-up time <sup>4</sup> Low range, low power Low range, high power High range, low power High range, high power  | t                              | _<br>_<br>_<br>_ | 600<br>400<br>5<br>15  | _<br>_<br>_<br>_ | ms                |
| 6   | D | Square wave input clock frequency (EREFS = 0, ERCLKEN = 1) FEE mode FBE or FBELP mode   | Onto.                          | 0.03125<br>0     | _                      | 50.33<br>50.33   | MHz<br>MHz        |

<sup>&</sup>lt;sup>1</sup> Data in Typical column was characterized at 3.0 V, 25 °C or is typical recommended value.

<sup>&</sup>lt;sup>2</sup> Load capacitors  $(C_1, C_2)$ , feedback resistor  $(R_F)$  and series resistor  $(R_S)$  are incorporated internally when RANGE = HGO = 0.

<sup>&</sup>lt;sup>3</sup> See crystal or resonator manufacturer's recommendation.

<sup>&</sup>lt;sup>4</sup> Proper PC board layout procedures must be followed to achieve specifications.



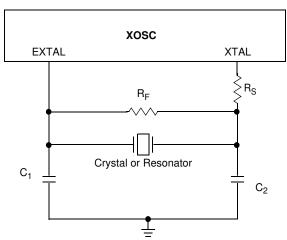


Figure 11. Typical Crystal or Resonator Circuit: High Range and Low Range/High Gain

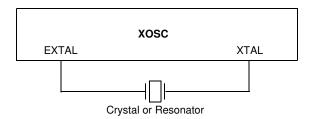


Figure 12. Typical Crystal or Resonator Circuit: Low Range/Low Gain

## 2.10 Internal Clock Source (ICS) Characteristics

Table 17. ICS Frequency Specifications (Temperature Range = -40 to 85 °C Ambient)

| Num | С | Characteristic   |                          |                          | Min   | Typical <sup>1</sup> | Max               | Unit              |
|-----|---|--|--------------------------|--------------------------|-------|----------------------|-------------------|-------------------|
| 1   | Р | Average internal reference frequency at $V_{DD} = 3.6 \text{ V}$ and temperate |                          | f <sub>int_ft</sub>      | _     | 32.768               | _                 | kHz               |
| 2   | Р | Internal reference frequency —   | user trimmed             | f <sub>int_ut</sub>      | 31.25 | _                    | 39.06             | kHz               |
| 3   | Т | Internal reference start-up time   |                          |                          | _     | 60                   | 100               | μS                |
|     | Р | Low range (DRS = 00)   |                          | 16                       | _     | 20                   |                   |                   |
| 4   | С | DCO output frequency range  — trimmed <sup>2</sup>                             | Mid range (DRS = 01)     | f <sub>dco_u</sub>       | 32    | _                    | 40                | MHz               |
|     | Р | tillilliod   | High range (DRS = 10)    |                          | 48    | _                    | 60                |                   |
|     | Р | DCO output frequency <sup>2</sup>  | Low range (DRS = 00)     |                          | _     | 19.92                | _                 |                   |
| 5   | Р | Reference = 32768 Hz   | Mid range (DRS = 01)     | f <sub>dco_DMX32</sub>   | _     | 39.85                | _                 | MHz               |
|     | Р | and DMX32 = 1  | High range (DRS = 10)    |                          | _     |                      |                   |                   |
| 6   | С | Resolution of trimmed DCO out and temperature (using FTRIM)                    | $\Delta f_{dco\_res\_t}$ | _                        | ±0.1  | ±0.2                 | %f <sub>dco</sub> |                   |
| 7   | С | Resolution of trimmed DCO outpand temperature (not using FTF                   |                          | $\Delta f_{dco\_res\_t}$ | _     | ±0.2                 | ±0.4              | %f <sub>dco</sub> |



Table 17. ICS Frequency Specifications (Temperature Range = -40 to 85 °C Ambient) (continued)

| Num | С | Characteristic  | Symbol               | Min | Typical <sup>1</sup> | Max | Unit              |
|-----|---|---|----------------------|-----|----------------------|-----|-------------------|
| 8   | С | Total deviation of trimmed DCO output frequency over voltage and temperature                              | $\Delta f_{dco\_t}$  | _   | 0.5<br>-1.0          | ±2  | %f <sub>dco</sub> |
| 9   | С | Total deviation of trimmed DCO output frequency over fixed voltage and temperature range of 0 °C to 70 °C | $\Delta f_{dco\_t}$  | _   | ±0.5                 | ±1  | %f <sub>dco</sub> |
| 10  | С | FLL acquisition time <sup>3</sup>   | t <sub>Acquire</sub> | _   | _                    | 1   | ms                |
| 11  | С | Long term jitter of DCO output clock (averaged over 2 ms interval) <sup>4</sup>                           | C <sub>Jitter</sub>  | _   | 0.02                 | 0.2 | %f <sub>dco</sub> |

<sup>&</sup>lt;sup>1</sup> Data in Typical column was characterized at 3.0 V, 25 °C or is typical recommended value.

Jitter is the average deviation from the programmed frequency measured over the specified interval at maximum f<sub>Bus</sub>. Measurements are made with the device powered by filtered supplies and clocked by a stable external clock signal. Noise injected into the FLL circuitry via V<sub>DD</sub> and V<sub>SS</sub> and variation in crystal oscillator frequency increase the C<sub>Jitter</sub> percentage for a given interval.

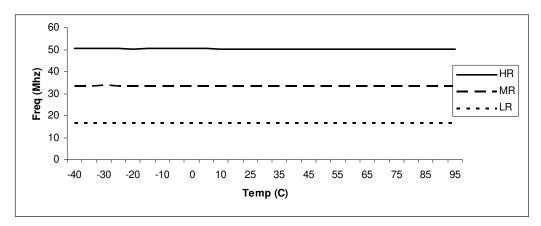


Figure 13. Deviation of DCO Output from Trimmed Frequency (50.33 MHz, 3.0 V)

<sup>&</sup>lt;sup>2</sup> The resulting bus clock frequency should not exceed the maximum specified bus clock frequency of the device.

<sup>&</sup>lt;sup>3</sup> This specification applies to any time the FLL reference source or reference divider is changed, trim value changed or changing from FLL disabled (FBELP, FBILP) to FLL enabled (FEI, FEE, FBE, FBI). If a crystal/resonator is being used as the reference, this specification assumes it is already running.



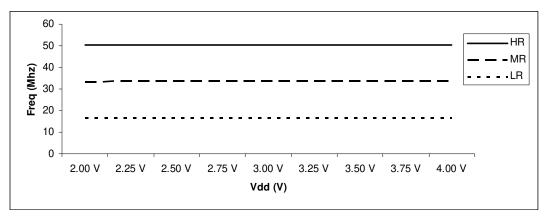


Figure 14. Deviation of DCO Output from Trimmed Frequency (50.33 MHz, 25 °C)

## 2.11 LCD Specifications

Table 18. LCD Electricals, 3 V Glass

| N  | С | Characteristic                               | Symbol               | Min  | Typical        | Max               | Unit                   |
|----|---|--|----------------------|------|----------------|-------------------|------------------------|
| 1  | D | LCD frame frequency                          | f <sub>Frame</sub>   | 28   | 30             | 58                | Hz                     |
| 2  | D | LCD charge pump capacitance                  | C <sub>LCD</sub>     |      | 100            | 100               | nF                     |
| 3  | D | LCD bypass capacitance                       | C <sub>BYLCD</sub>   |      | 100            | 100               | nF                     |
| 4  | D | LCD glass capacitance                        | C <sub>glass</sub>   |      | 2000           | 8000              | pF                     |
| 5  | D | HRefSel =                                    | 0 ,                  | .89  | 1.00           | 1.15              | V                      |
| 6  | ם | V <sub>IREG</sub> HRefSel =                  | 1 V <sub>IREG</sub>  | 1.49 | 1.67           | 1.85 <sup>1</sup> | V                      |
| 7  | D | V <sub>IREG</sub> trim resolution            | $\Delta_{RTRIM}$     | 1.5  |                |                   | %<br>V <sub>IREG</sub> |
| 8  | D | HRefSel =                                    | 0                    |      |                | 0.1               | V                      |
| 0  | ט | V <sub>IREG</sub> ripple HRefSel =           | 1                    |      |                | 0.15              | 7 V                    |
| 9  | D | V <sub>IREG</sub> current adder RVEN =       | 1 I <sub>VIREG</sub> | _    | 1 <sup>2</sup> |                   | μΑ                     |
| 10 | D | V <sub>LCD</sub> buffered adder <sup>3</sup> | I <sub>Buff</sub>    | _    | 1              |                   | μΑ                     |

 $V_{\rm IREG}$  Max can not exceed  $V_{\rm DD}$  – 0.15 V

### 2.12 AC Characteristics

This section describes AC timing characteristics for each peripheral system.

<sup>&</sup>lt;sup>2</sup> 2000 pF Load LCD, frame frequency = 32 Hz

<sup>&</sup>lt;sup>3</sup> VSUPPLY = 10, BYPASS = 0



## 2.12.1 Control Timing

**Table 19. Control Timing** 

| Num | С | Parameter   | Symbol                                | Min                           | Typical <sup>1</sup> | Max    | Unit |
|-----|---|---|---------------------------------------|-------------------------------|----------------------|--------|------|
| 1   | D | Bus frequency (t <sub>cyc</sub> = 1/f <sub>Bus</sub> )  | f <sub>Bus</sub>                      | DC                            | _                    | 25.165 | MHz  |
| 2   | D | Internal low-power oscillator period  | t <sub>LPO</sub>                      | 700                           |                      | 1300   | μS   |
| 3   | D | External reset pulse width <sup>2</sup> (t <sub>cyc</sub> = 1/f <sub>Self_reset</sub> )   | t <sub>extrst</sub>                   | 100                           |                      | _      | ns   |
| 4   | D | Reset low drive   | t <sub>rstdrv</sub>                   | $66 \times t_{cyc}$           |                      | _      | ns   |
| 5   | D | Active background debug mode latch setup time   | t <sub>MSSU</sub>                     | 500                           |                      | _      | ns   |
| 6   | D | Active background debug mode latch hold time  | t <sub>MSH</sub>                      | 100                           |                      | _      | ns   |
| 7   | D | IRQ pulse width  Asynchronous path <sup>2</sup> Synchronous path <sup>3</sup>   | t <sub>ILIH,</sub> t <sub>IHIL</sub>  | 100<br>1.5 × t <sub>cyc</sub> | _                    | _      | ns   |
| 8   | D | KBIPx pulse width  Asynchronous path <sup>2</sup> Synchronous path <sup>3</sup>   | t <sub>ILIH,</sub> t <sub>IHIL</sub>  | 100<br>1.5 × t <sub>cyc</sub> | _                    | _      | ns   |
| 9   | D | Port rise and fall time (load = 50 pF) <sup>4</sup> Slew rate control disabled (PTxSE = 0), low drive Slew rate control enabled (PTxSE = 1), low drive Slew rate control disabled (PTxSE = 0), low drive Slew rate control enabled (PTxSE = 1), low drive | t <sub>Rise</sub> , t <sub>Fall</sub> |                               | 11<br>35<br>40<br>75 |        | ns   |

Typical values are based on characterization data at  $V_{DD} = 5.0 \text{ V}$ , 25 °C unless otherwise stated.

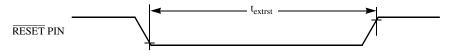


Figure 15. Reset Timing

<sup>&</sup>lt;sup>2</sup> This is the shortest pulse that is guaranteed to be recognized as a reset pin request. Shorter pulses are not guaranteed to override reset requests from internal sources.

<sup>&</sup>lt;sup>3</sup> This is the minimum pulse width that is guaranteed to pass through the pin synchronization circuitry. Shorter pulses may or may not be recognized. In stop mode, the synchronizer is bypassed so shorter pulses can be recognized in that case.

 $<sup>^4</sup>$  Timing is shown with respect to 20%  $\rm V_{DD}$  and 80%  $\rm V_{DD}$  levels. Temperature range –40  $^{\circ}C$  to 105  $^{\circ}C$ .



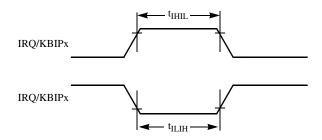


Figure 16. IRQ/KBIPx Timing

## 2.12.2 Timer (TPM/FTM) Module Timing

Synchronizer circuits determine the shortest input pulses that can be recognized or the fastest clock that can be used as the optional external source to the timer counter. These synchronizers operate from the current bus rate clock.

Table 20. TPM Input Timing

| No. | С | Function                  | Symbol            | Min | Max                 | Unit             |
|-----|---|---------------------------|-------------------|-----|---------------------|------------------|
| 1   | D | External clock frequency  | f <sub>TCLK</sub> | 0   | f <sub>Bus</sub> /4 | Hz               |
| 2   | D | External clock period     | t <sub>TCLK</sub> | 4   | _                   | t <sub>cyc</sub> |
| 3   | D | External clock high time  | t <sub>clkh</sub> | 1.5 | _                   | t <sub>cyc</sub> |
| 4   | D | External clock low time   | t <sub>clkl</sub> | 1.5 | _                   | t <sub>cyc</sub> |
| 5   | D | Input capture pulse width | t <sub>ICPW</sub> | 1.5 | _                   | t <sub>cyc</sub> |

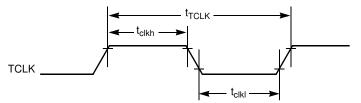


Figure 17. Timer External Clock

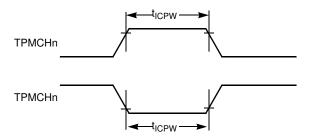


Figure 18. Timer Input Capture Pulse



### 2.13 VREF Characteristics

**Table 21. VREF Electrical Specifications** 

| Num | С      | Characteristic   | Symbol   | Min Typical Max                    |        | Unit  |          |
|-----|--------|--|--|------------------------------------|--------|-------|----------|
| 1   | _      | Supply voltage   | $V_{DDAD}$   | 1.80                               | _      | 3.60  | V        |
| 2   | _      | Operating temperature range                            | T <sub>op</sub>  | -40                                | _      | 105   | °C       |
| 3   | D      | Load capability  | I <sub>load</sub>  | _                                  | _      | 10    | mA       |
| 4   | C<br>P |  | reference output untrimmed V <sub>REFO</sub> 1.070 — 1.202 factory trimmed 1.04 1.150 1.17 |                                    | V<br>V |       |          |
| 5   | D      | Load regulation<br>mode = 10, I <sub>load</sub> = 1 mA |  | 20 — 100                           |        | μV/mA |          |
| 6   | Т      | Line regulation (power supply rejection)  DC AC        |  | ±0.1 from room temp voltage<br>-60 |        |       | mV<br>dB |
| 7   | Т      | Bandgap only (mode = 00)                               | I <sub>BG</sub>  | _                                  | 72     | _     | μА       |
| 8   | С      | Low power mode (mode = 01)                             | I <sub>LP</sub>  | _                                  | 90     | 125   | μА       |
| 9   | Т      | Tight regulation mode (mode =10)                       | I <sub>TR</sub>  | _                                  | 0.27   | _     | mA       |

## 2.14 SPI Characteristics

Table 22 and Figure 19 through Figure 22 describe the timing requirements for the SPI system.



Table 22. SPI Electrical Characteristic 1,2

| Num <sup>3</sup> | С | Characteristic <sup>4</sup>                    | Symbol           | Min                    | Max  | Unit               |
|------------------|---|--|------------------|------------------------|--|--------------------|
| 1                | D | Operating frequency  Mast Slav                 |                  | f <sub>Bus</sub> /2048 | f <sub>Bus</sub> /2<br>f <sub>Bus</sub> /4 | Hz                 |
| 2                | D | SPSCK period  Mast Slav                        |                  | 2<br>4                 | 2048<br>—                                  | t <sub>cyc</sub>   |
| 3                | D | Enable lead time<br>Mast<br>Slav               | T                | 1/2                    | _  | t <sub>SPSCK</sub> |
| 4                | D | Enable lag time<br>Mast<br>Slav                |                  | 1/2                    | _  | t <sub>SPSCK</sub> |
| 5                | D | Clock (SPSCK) high or low time<br>Mast<br>Slav |                  | t <sub>cyc</sub> – 30  | 1024 t <sub>cyc</sub>                      | ns                 |
| 6                | D | Data setup time (inputs)  Mast Slav            | Ta.              | 15<br>15               | _  | ns                 |
| 7                | D | Data hold time (inputs)  Mast Slav             | †                | 0<br>25                | _  | ns                 |
| 8                | D | Slave access time <sup>5</sup>                 | t <sub>a</sub>   | _                      | 1  | t <sub>cyc</sub>   |
| 9                | D | Slave MISO disable time <sup>6</sup>           | t <sub>dis</sub> | _                      | 1  | t <sub>cyc</sub>   |
| 10               | D | Data valid (after SPSCK edge)  Mast Slav       |                  |                        | 25<br>25                                   | ns                 |
| 11               | D | Data hold time (outputs)  Mast Slav            |                  | 0                      | _  | ns                 |
| 12               | D | Rise time<br>Inp<br>Outp                       |                  |                        | t <sub>cyc</sub> – 25<br>—25               | ns                 |
| 13               | D | Fall time<br>Inp<br>Outp                       |                  |                        | t <sub>cyc</sub> – 25<br>—25               | ns                 |

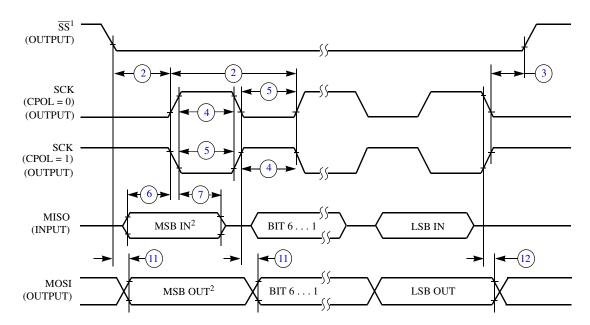
The performance of SPI2 depends on the configuration of power supply of the LCD pins. When the LCD pins are configured with full complementary drive enabled (FCDEN = 1, VSUPPLY = 11 and RVEN = 0), and VLL3 is driven with external VDD, the SPI2 can operate at the max performance as the above table. When the internal LCD charge pump is used to power the LCD pins, the SPI2 is configured with open-drain outputs. Its performance depends on the value of the external pullup resistor implemented, and the max operating frequency must be limited to 1 MHz.

<sup>&</sup>lt;sup>2</sup> SPI3 has open-drain outputs and its performance depends on the value of the external pullup resistor implemented.

<sup>&</sup>lt;sup>3</sup> Refer to Figure 19 through Figure 22.



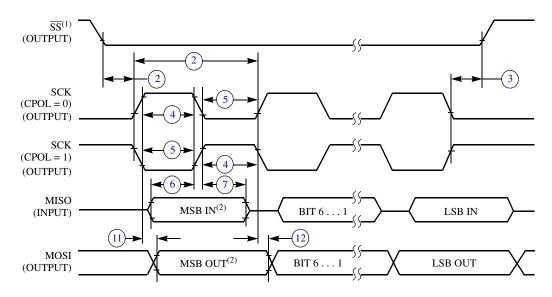
- $^4$  All timing is shown with respect to 20%  $\rm V_{DD}$  and 70%  $\rm V_{DD}$ , unless noted; 100 pF load on all SPI pins. All timing assumes slew rate control disabled and high drive strength enabled for SPI output pins.
- <sup>5</sup> Time to data active from high-impedance state.
- <sup>6</sup> Hold time to high-impedance state.



#### NOTES:

- 1.  $\overline{SS}$  output mode (MODFEN = 1, SSOE = 1).
- 2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

Figure 19. SPI Master Timing (CPHA = 0)



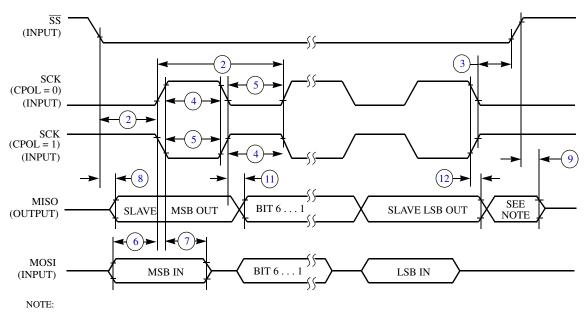
#### NOTES:

- 1.  $\overline{SS}$  output mode (MODFEN = 1, SSOE = 1).
- 2. LSBF = 0. For LSBF = 1, bit order is LSB, bit 1, ..., bit 6, MSB.

Figure 20. SPI Master Timing (CPHA = 1)

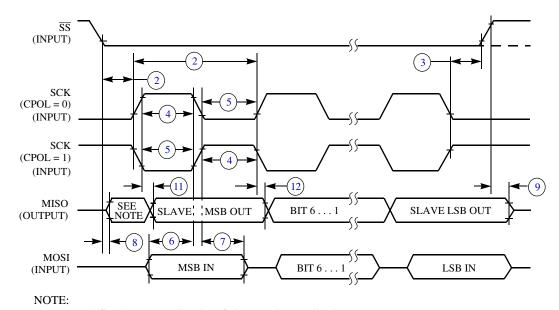
MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3





1. Not defined but normally MSB of character just received

Figure 21. SPI Slave Timing (CPHA = 0)



1. Not defined but normally LSB of character just received

Figure 22. SPI Slave Timing (CPHA = 1)

## 2.15 Flash Specifications

This section provides details about program/erase times and program-erase endurance for the flash memory.

Program and erase operations do not require any special power sources other than the normal  $V_{DD}$  supply. For more detailed information about program/erase operations, see the Memory section of the MCF51EM256 Series ColdFire Microcontroller Reference Manual.



**Table 23. Flash Characteristics** 

| N  | С | Characteristic  | Symbol                  | Min     | Typical     | Max    | Unit              |
|----|---|---|-------------------------|---------|-------------|--------|-------------------|
| 1  | D | Supply voltage for program/erase<br>–40 °C to 85 °C                               | V <sub>prog/erase</sub> | 1.8 3.6 |             | V      |                   |
| 2  | D | Supply voltage for read operation   | V <sub>Read</sub>       | 1.8     |             | 3.6    | V                 |
| 3  | D | Internal FCLK frequency <sup>1</sup>  | f <sub>FCLK</sub>       | 150     |             | 200    | kHz               |
| 4  | D | Internal FCLK period (1/f <sub>FCLK</sub> )                                       | t <sub>Fcyc</sub>       | 5       |             | 6.67   | μS                |
| 5  | Р | Longword program time (random location) <sup>2</sup>                              | t <sub>prog</sub>       | 9       |             |        | t <sub>Fcyc</sub> |
| 6  | Р | Longword program time (burst mode) <sup>2</sup>                                   | t <sub>Burst</sub>      | 4       |             |        | t <sub>Fcyc</sub> |
| 7  | Р | Page erase time <sup>2</sup>  | t <sub>Page</sub>       | 4000    |             |        | t <sub>Fcyc</sub> |
| 8  | Р | Mass erase time <sup>2</sup>  | t <sub>Mass</sub>       |         | 20,000      |        | t <sub>Fcyc</sub> |
| 9  |   | Longword program current <sup>3</sup>   | R <sub>IDDBP</sub>      |         | 9.7         | _      | mA                |
| 10 |   | Page erase current <sup>3</sup>   | R <sub>IDDPE</sub>      |         | 7.6         | _      | mA                |
| 11 | С | Program/erase endurance <sup>4</sup> $T_L$ to $T_H = -40$ °C to 85 °C $T = 25$ °C |                         | 10,000  | <br>100,000 | _<br>_ | cycles            |
| 12 | С | Data retention <sup>5</sup>   | t <sub>D_ret</sub>      | 15      | 100         | _      | years             |

<sup>&</sup>lt;sup>1</sup> The frequency of this clock is controlled by a software setting.

#### 2.16 EMC Performance

Electromagnetic compatibility (EMC) performance is highly dependant on the environment in which the MCU resides. Board design and layout, circuit topology choices, location and characteristics of external components as well as MCU software operation all play a significant role in EMC performance. The system designer should consult Freescale applications notes such as AN2321, AN1050, AN1263, AN2764, and AN1259 for advice and guidance specifically targeted at optimizing EMC performance.

#### 2.16.1 Radiated Emissions

Microcontroller radiated RF emissions are measured from 150 kHz to 1 GHz using the TEM/GTEM Cell method in accordance with the IEC 61967-2 and SAE J1752/3 standards. The measurement is performed with the microcontroller installed on a custom EMC evaluation board while running specialized EMC test software. The radiated emissions from the microcontroller are measured in a TEM cell in two package orientations (North and East). For more detailed information concerning the evaluation results, conditions and setup, please refer to the EMC Evaluation Report for this device.

<sup>&</sup>lt;sup>2</sup> These values are hardware state machine controlled. User code does not need to count cycles. This information supplied for calculating approximate time to program and erase.

<sup>&</sup>lt;sup>3</sup> The program and erase currents are additional to the standard run  $I_{DD}$ . These values are measured at room temperatures with  $V_{DD} = 3.0 \text{ V}$ , bus frequency = 4.0 MHz.

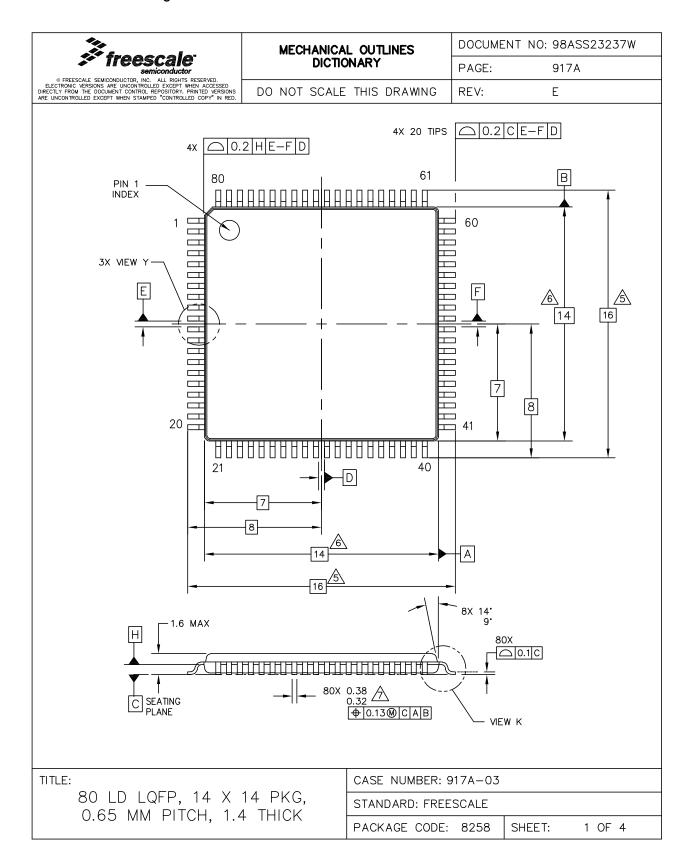
Typical endurance for flash was evaluated for this product family on the HC9S12Dx64. For additional information on how Freescale defines typical endurance, please refer to Engineering Bulletin EB619, Typical Endurance for Nonvolatile Memory.

Typical data retention values are based on intrinsic capability of the technology measured at high temperature and de-rated to 25°C using the Arrhenius equation. For additional information on how Freescale defines typical data retention, please refer to Engineering Bulletin EB618, Typical Data Retention for Nonvolatile Memory.



- 3 Mechanical Outline Drawings
- 3.1 80-pin LQFP Package







# \*\*freescale\*

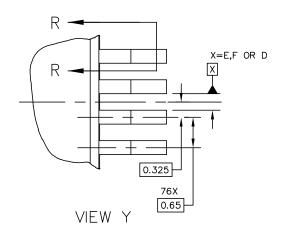
© FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. ELECTRONIC VERSIONS ARE UNCONTROLLED EXCEPT WHEN ACCESSED DIRECTLY FROM THE DOCUMENT CONTROL REPOSITORY, PRINTED VERSIONS ARE UNCONTROLLED EXCEPT WHEN STAMPED "CONTROLLED COPY" IN RED

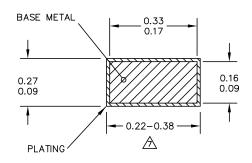
## MECHANICAL OUTLINES DICTIONARY

DO NOT SCALE THIS DRAWING

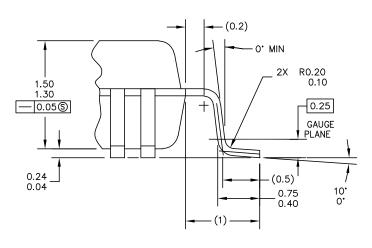
| DOCUMENT | NO: | 98ASS23237W |  |
|----------|-----|-------------|--|
| PAGE:    |     | 917A        |  |

PAGE: 917A REV: E





SECTION R-R ROTATED 90' CW



VIEW K

TITLE:

80 LD LQFP, 14 X 14 PKG, 0.65 MM PITCH, 1.4 THICK

CASE NUMBER: 917A-03

STANDARD: FREESCALE

PACKAGE CODE: 8258 SHEET: 2 OF 4



| the second of  | MECHANICAL OUTLINES       | DOCUMENT NO: 98ASS23237W |      |  |
|--|---------------------------|--------------------------|------|--|
| ** freescale* semiconductor  | DICTIONARY                | PAGE:                    | 917A |  |
| © FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED.<br>ELECTRONIC VERSIONS ARE UNCONTROLLED EXCEPT WHEN ACCESSED<br>DIRECTLY FROM THE DOCUMENT CONTROL REPOSITORY, PRINTED VERSIONS<br>ARE UNCONTROLLED EXCEPT WHEN STAMPED "CONTROLLED COPY" IN RED. | DO NOT SCALE THIS DRAWING | REV:                     | E    |  |

#### NOTES:

- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994.
- 2. CONTROLLING DIMENSION: MILIMETER.
- 3. DATUM PLANE H IS LOCATED AT THE BOTTOM OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
- 4. DATUM E, F AND D TO BE DETERMINED AT DATUM PLANE H.
- DIMENSIONS TO BE DETERMINED AT SEATING PLANE C.

  DIMENSIONS DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.25
  PER SIDE. DIMENSIONS DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.

| $\Delta$ | DIMENSION DOES NOT INCLUDE DAMBAR PROT | USION. DAMBAR PR  | OTRUSION SHALL NOT |
|----------|--|-------------------|--------------------|
|          | CAUSE THE LEAD WIDTH TO EXCEED 0.46. N | NIMUM SPACE BETWE | EN PROTRUSION AND  |
|          | ADJACENT LEAD OR PROTRUSION 0.07.      |                   |                    |

TITLE:

80 LD LQFP, 14 X 14 PKG,
0.65 MM PITCH, 1.4 THICK

CASE NUMBER: 917A-03

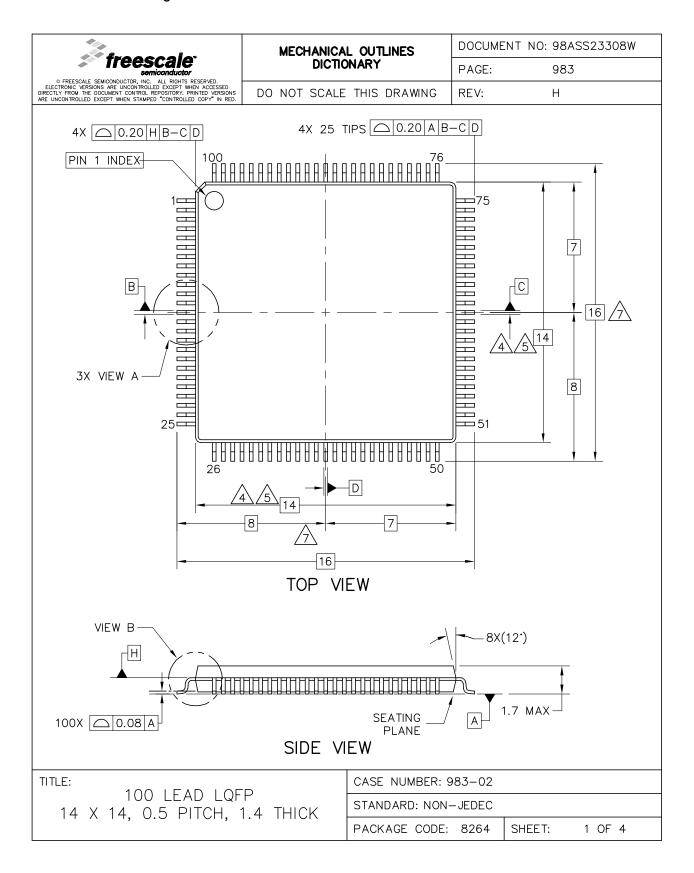
STANDARD: FREESCALE

PACKAGE CODE: 8258 SHEET: 3 OF 4



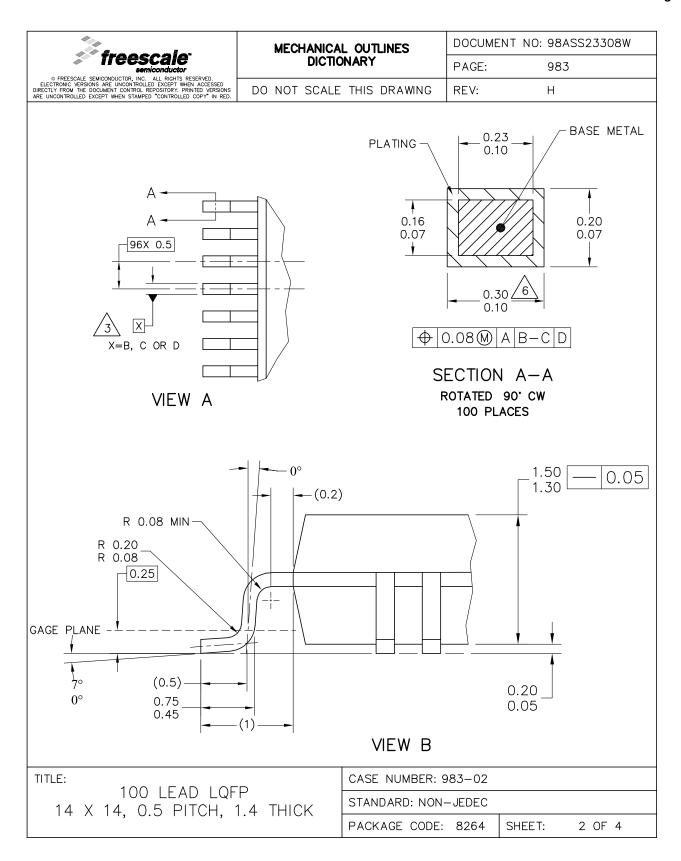
## 3.2 100-pin LQFP Package













|  | MECHANICAL OUTLINES   | DOCUMENT NO: 98ASS23308W |          |  |
|--|---|--------------------------|----------|--|
| Treescale* semiconductor   | Treescale DICTIONARY  semiconductor Reserved.  JOHN ARE INCONTROLLER RESERVED.  JOHN ARE INCONTROLLER RESERVED. |                          | 983      |  |
| FREESCALE SEMICONDUCTOR, INC. ALL RIGHTS RESERVED. ELECTRONIC VERSIONS ARE UNCONTROLLED EXCEPT WHEN ACCESSED RECTLY FROM THE DOCUMENT CONTROL REPOSITORY, PRINTED VERSIONS RE UNCONTROLLED EXCEPT WHEN STAMPED "CONTROLLED COPY" IN RED. | DO NOT SCALE THIS DRAWING   | REV:                     | Н        |  |
| NOTES:   |   |                          |          |  |
| 1. ALL DIMENSIONS ARE IN MILL  | IMETERS.  |                          |          |  |
| 2. INTERPRET DIMENSIONS AND  | TOLERANCES PER ASME Y14.5M-1  | 994.                     |          |  |
| 3. DATUMS B, C AND D TO BE   | DETERMINED AT DATUM PLANE H.  |                          |          |  |
| 4. THE TOP PACKAGE BODY SIZ<br>BY A MAXIMUM OF 0.1 MM.   | ZE MAY BE SMALLER THAN THE BO   | OTTOM PACK               | AGE SIZE |  |
| 5. DIMENSIONS DO NOT INCLUDE PROTRUSION IS 0.25 mm PE SIZE DIMENSIONS INCLUDING  | E MOLD PROTRUSIONS. THE MAXIMER SIDE. THE DIMENSIONS ARE MA<br>MOLD MISMATCH.                                   | UM ALLOWAE<br>XIMUM BODY | BLE      |  |
|  | DE DAM BAR PROTRUSION. PROTRU<br>EXCEED 0.35. MINIMUM SPACE BE<br>IALL BE 0.07 MM.                              |                          |          |  |
| $\sqrt{2}$ . Dimensions are determined   | AT THE SEATING PLANE, DATUM   | A.                       |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |
|  |   |                          |          |  |

MCF51EM256 Series ColdFire Microcontroller Data Sheet, Rev.3

CASE NUMBER: 983-02

STANDARD: NON-JEDEC

PACKAGE CODE: 8264

3 OF 4

SHEET:

TITLE:

100 LEAD LQFP

14 X 14, 0.5 PITCH, 1.4 THICK



## 4 Revision History

**Table 24. Revision History** 

| Revision | Date       | Description  |
|----------|------------|--|
| 1        | 10/15/2009 | Initial public release.  |
| 2        | 4/29/2010  | Updated teh descriptions of SPI in the Table 2. Changed the FSPIx to SPI16 to keep the term in accordance. Updated Figure 4 to Figure 8. Updated WI <sub>DD</sub> , S2I <sub>DD</sub> , S3I <sub>DD</sub> in the Table 11. Updated the ADC characteristics in the Table 13 to Table 15. Updated description of XOSC in the Section 2.9, "External Oscillator (XOSC) Characteristics." Updated t <sub>CSTL</sub> in the Table 16. Updated the the classification of IBG and ITR to T and added Voltage reference output (factory trimmed) in the Table 21. Update SPI data in the Table 22. |
| 3        | 8/9/2010   | Updated the $V_{DD}$ at 20 MHz maximum operation to 3.6 V. Updated the $RI_{DD}$ (at Run supply current FEI mode, all module on), $S2I_{DD}$ and $S3I_{DD}$ at 3 V, $S3I_{DDLVD}$ in the Table 11. Updated ENOB at 16 bit single-ended mode in the Table 14.   |



#### How to Reach Us:

#### Home Page:

www.freescale.com

#### Web Support:

http://www.freescale.com/support

#### **USA/Europe or Locations Not Listed:**

Freescale Semiconductor, Inc.
Technical Information Center, EL516
2100 East Elliot Road
Tempe, Arizona 85284
1-800-521-6274 or +1-480-768-2130
www.freescale.com/support

#### Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH Technical Information Center Schatzbogen 7 81829 Muenchen, Germany +44 1296 380 456 (English) +46 8 52200080 (English) +49 89 92103 559 (German) +33 1 69 35 48 48 (French) www.freescale.com/support

#### Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku, Tokyo 153-0064 Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

#### Asia/Pacific:

Asia Pacific:
Freescale Semiconductor China Ltd.
Exchange Building 23F
No. 118 Jianguo Road
Chaoyang District
Beijing 100022
China
+86 10 5879 8000
support.asia@freescale.com

#### For Literature Requests Only:

Freescale Semiconductor Literature Distribution Center P.O. Box 5405
Denver, Colorado 80217
1-800-441-2447 or +1-303-675-2140
Fax: +1-303-675-2150
LDCForFreescaleSemiconductor@hibbertgroup.com

Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductor products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Freescale Semiconductor was negligent regarding the design or manufacture of the part.



 $\label{eq:Freescale} \textbf{Freescale} \ \textbf{Important Preescale logo} \ \text{are trademarks of Freescale Semiconductor, Inc. All other product or service names are the property of their respective owners.}$ 

© Freescale Semiconductor, Inc. 2008-2009. All rights reserved.